

Scalable Performance Oscilloscopes

DPO70000SX Series Datasheet

DPO70000SX provides ultra-high bandwidth real time signal acquisition and analysis up to 70 GHz analog bandwidth. The patented Asynchronous Time Interleaving (ATI) architecture provides the lowest noise and highest fidelity for real time signal acquisition.

- Superior signal fidelity and excellent signal-to-noise ratio
- Stable and precise multi-channel timing for most accurate analysis
- Compact instrument package with flexibility for future expansion and simple reconfiguration

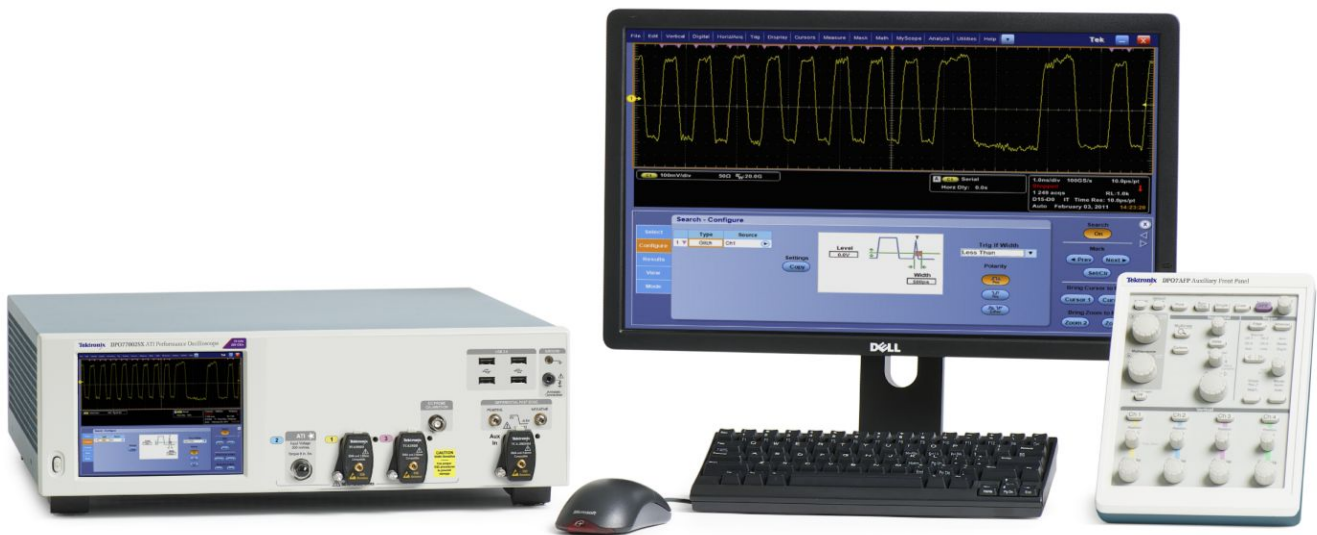
Introduction

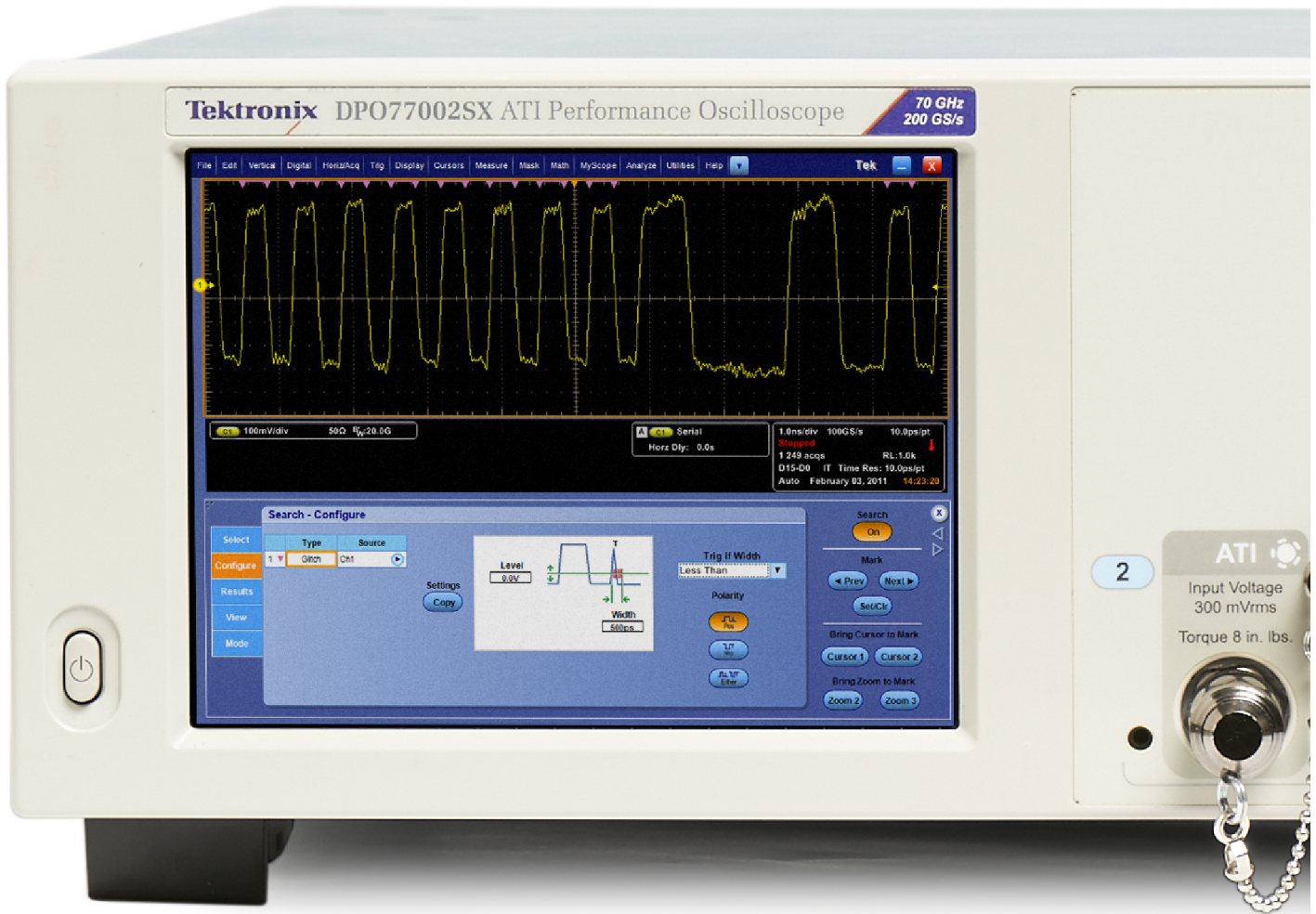
DPO70000SX Series oscilloscopes provide the most accurate real time performance for ultra-bandwidth applications.

- Low noise, 70 GHz real time signal capture using patented ATI architecture
- Compact 5 ¼" (3U) instrument package for the most versatile multi-channel systems

- Precise, scalable performance using UltraSync multi-unit time synchronization bus
- Highest trigger performance with >25 GHz Edge trigger bandwidth, unique Envelope trigger
- 14.1 Gbps hardware serial trigger - Assures triggering on the first instance of a specified 8b10b pattern to allow isolation of pattern-dependent effects.

Low noise, high fidelity signal acquisition is critical in ultra-bandwidth applications such as long-haul coherent optical, 400G datacom and wideband RF. The flagship DPO77002SX model uses ATI (Asynchronous Time Interleaving) architecture to achieve 70 GHz and 200 GS/s (5 ps/Sample) real time acquisition performance. This patented, symmetric architecture elegantly creates an inherent noise advantage over legacy bandwidth interleaving methods. The DPO70000SX provides the lowest noise, highest fidelity and maximum performance for complex optical modulation analysis, jitter and noise analysis of high speed serial signaling and frequency, phase and modulation analysis of wideband RF signals.





DPO70000SX ATI Performance Oscilloscopes

- 70 GHz, 59 GHz, or 50 GHz analog bandwidth
- Low-noise ATI architecture
- 200 GS/s, 5 ps/Sample real-time sample rate

DPO70000SX Digital Phosphor Oscilloscopes

- 33 GHz or 23 GHz analog bandwidth
- 100 GS/s, 10 ps/Sample real-time sample rate



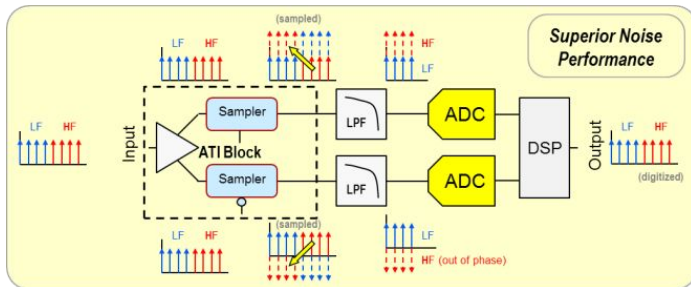
Applications

- Coherent optical modulation analysis
- Research and defense data acquisition and analysis
- 100G/400G datacom system debug
- PCIe debugging and compliance testing

ATI architecture delivers lowest noise

Previous real time scope solutions for digitizing ultra-high bandwidth signals distribute signal energy to two digitizing paths, and then use DSP to reconstruct the input signal. Unlike legacy schemes, Tektronix' unique ATI architecture provides a symmetric technique that delivers all signal energy to both digitizing paths resulting in an inherent noise advantage.

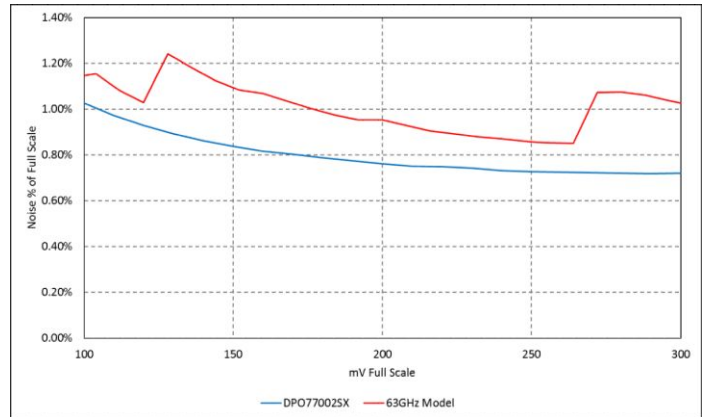
The diagram shows how an input signal enters the ATI ASIC where it is sampled and alternately delivered to each digitizing subsystem. The sample clock runs at 75 GHz and effectively folds the spectrum of the input signal about 37.5 GHz prior to digitizing. Each digitizing path operates at 100 GS/s and the folded spectrum is band limited to <40 GHz to meet Nyquist criteria. The alternating phase of the sampler has the effect of inverting signal phase 180° in one digitizing path, which provides significant benefit in reconstructing the final digitized signal.



With two copies of the entire signal energy digitized, the signal spectra are "unfolded" using a DSP equivalent of the sampling process and combined to reproduce the input signal. Because two copies of the signal are being combined the process effectively averages them together, reducing random noise. Phase-inversion introduced by the sampling process causes intermediate frequency components to directly cancel one another, simplifying reconstruction and calibration.

Thus, ATI architecture provides an inherent SNR advantage over legacy digital-bandwidth interleaving techniques. These techniques immediately split an input signal into upper and lower bands of frequencies. This divides the power and the upper frequency band must be mixed down prior to digitizing while the lower band is directly digitized. This asymmetric approach can make signal reconstruction and calibration more difficult and lead to errors in pass-band frequency or phase response. The division of power removes the opportunity to reduce signal noise. ATI alleviates these issues by using a unique symmetric architecture.

A comparison of baseline noise between the Tektronix DPO77002SX and another vendor's 63 GHz model, with both instruments set to 60 GHz bandwidth, demonstrates the effectiveness of ATI at providing the lowest noise acquisition.

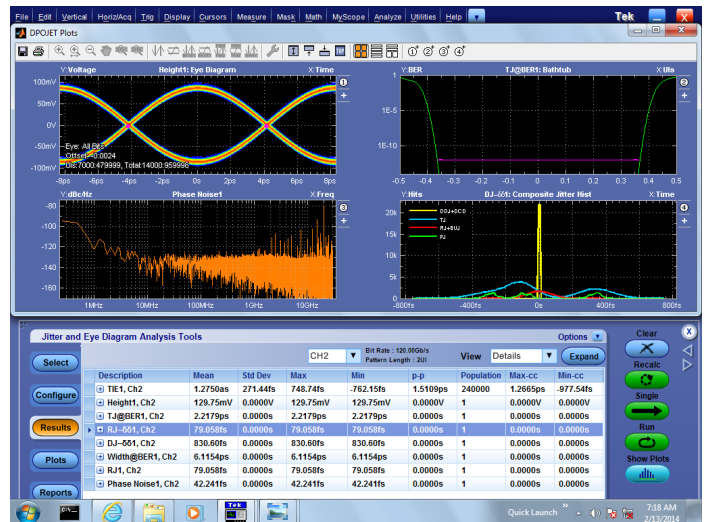


DPO77002SX vs. other vendor's 63 GHz model: Baseline noise % of FS vs. mV_{FS} setting, with trace centered, at 60 GHz BW, maximum sample rate setting (200 GS/s or 160 GS/s)

JNF performance

An all-new master sample clock design which provides the remarkably low sample clock jitter of 65fs_{RMS}, combined with the very low noise performance achieved with ATI, allows the DPO77002SX to reach new levels of jitter noise floor performance. The JNF at 300 mV_{FS} is a mere 123 fs_{RMS}, which even rivals lower bandwidth instruments.

The figure shows jitter analysis of 60 GHz sine wave applied to the ATI input. The result shows a clean eye with random jitter RJ <80 fs_{RMS}.



Compact ultra-performance oscilloscope

DPO7000SX Series models establish a unique compact oscilloscope package that enables unprecedented workspace efficiency and mounting versatility. The SX series provides a differentiated approach to ultra-bandwidth real time acquisition that aligns with user trends toward large external monitors, higher degrees of automation and increased separation of data collection and data analysis workspaces.

Stand-alone DPO7000SX compact models provide functionality equivalent to their bench counterparts (DPO7000DX) at half the height through addition of external display, keyboard and mouse. SX series models can host Advanced Analysis software and be automated using internal or external control just as their bench counterparts.

The DPO77002SX 70 GHz ATI Performance Oscilloscope provides one channel at 70 GHz, 200 GS/s acquisition performance or two channels at 33 GHz, 100 GS/s acquisition. The instrument includes a 70 GHz, 1.85 mm low-noise ATI input channel as well as general purpose TekConnect 2.92 mm inputs for versatile probing and signal conditioning options to 33 GHz.



The DPO73304SX model provides two channels at 33 GHz, 100 GS/s acquisition or four channels at 23 GHz, 50 GS/s real time acquisition performance. This model provides acquisition performance similar to the DPO73304DX bench model, but in the new compact instrument form-factor.

All models in the DPO7000SX Series achieve the highest level of trigger performance available in real time oscilloscopes, >25 GHz edge trigger performance and <40 ps glitch trigger performance. An innovative new Window trigger type enables triggering on the envelope of RF signal bursts with time-qualification to discriminate envelope width. Industry-leading pulse-width timer performance enables the most precise discrimination of specific bit-widths in high speed serial data streams and detection of "runt" pulses in the midst of pseudo-random signaling. The DPO7000SX Series Auxiliary Trigger input provides low-jitter edge triggering and uses TekConnect accessories for a wide variety of signal conditioning solutions.

Optimal usability

Less than half the height of bench models

DPO7000SX Series instruments are contained in a 5 1/4" (3U) package that optimizes space usage and enables the most versatile range of mounting configurations. Two DPO7000SX instruments stack in less height than similar-class bench instruments, yet achieve higher measurement performance.

Complete standalone oscilloscope

Though compact, SX models provide full standalone oscilloscope functionality and performance. They can directly host Tektronix' Advanced Analysis applications for tasks such as jitter, noise, optical modulation or spectral analysis and do not require a separate processor or control unit.



2 x 70 GHz, 4 x 33 GHz configuration with monitor and auxiliary front panel

Familiar scope controls where you want them

The DPO7AFP Auxiliary Front Panel is a valuable usability accessory that compliments the compact instrument package by enabling users to operate with familiar controls without requiring access to the front of an instrument.



The Auxiliary Front Panel provides the same control set embedded in DPO/ DSA/MSO/7000/70000 bench instruments as a separately packaged USB peripheral. This accessory enhances usability even when the instrument front panel may be obscured due to mounting location.



Remote desktop operation

As with current bench-model DPO/MSO70000 Series instruments, DPO70000SX models can be operated remotely over a network using Windows® Remote Desktop. Use the Windows Remote Desktop utility to access your oscilloscope from across the lab or across the globe.

Precision synchronization for multi-unit systems

DPO70000SX Series instruments include the Tektronix UltraSync multi-unit time synchronization bus. UltraSync is used to synchronize sample clock, trigger and run-stop control across multiple units with performance equivalent to that found in monolithic scopes. UltraSync cables are available in 1 meter and 2 meter length to maximize configuration and layout versatility while preserving timing integrity of a multi-unit system.



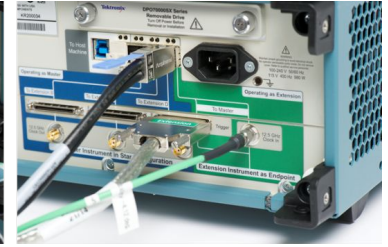
- 12.5 GHz Sample Clock Reference
- Coordinated Trigger
- High speed data path

The UltraSync bus consists of three elements, each providing an important element of precise multi-unit operation:

- UltraSync includes a 12.5 GHz Sample Clock Reference signal sourced by the Master and used by each Extension to synchronize sample placement in the digitizing process.



UltraSync connection on instrument with Master role

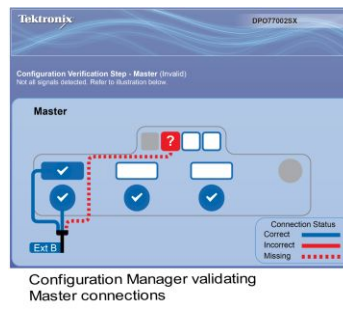


UltraSync connection on instrument with Extension role

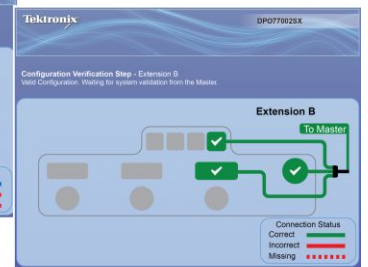
- The Trigger bus provides Run-Stop control for all members of a multi-unit configuration and enables the trigger source to be from a Master or Extension unit.
- Control & data transfer from Extension units to the Master are managed with a PCIe, Gen 2, x4 link capable of 2 GB/s data transfer rate.

When operating in a multi-unit instrument configuration, one DPO70000SX has the role of Master, controlling one or more units operating in Extension mode. Any DPO70000SX model can operate as a standalone oscilloscope or serve as Master or Extension in a multi-unit configuration. Roles are determined by UltraSync cabling and no additional elements are needed. This allows users to decouple multi-unit configurations at any time and operate instruments in a standalone fashion without requiring a control unit or other accessories. Or, standalone units can be easily combined by simply adding UltraSync cables between Master and Extension.

During startup of a multi-unit configuration a Configuration Manager application validates Master-Extension cabling and provides graphical feedback if elements are missing or misconfigured. Following validation, the system presents the TekScope user interface where waveforms from Master and Extension units are gathered for display and analysis using built-in features and Advanced Analysis applications.



Configuration Manager validating Master connections



Configuration Manager validating Extension connections

Scalable performance and versatile configurations

DPO70000SX multi-unit modes enable a variety of extended performance and increased channel-count configurations. Master-Extension configurations provide additional input channels synchronized to the same degree of precision as internal channels and controlled from a single user interface as an interactive instrument or programming interface in automated applications.

This scalable approach to performance allows users to purchase performance suitable for today's requirements, such as four channels of 33 GHz, 100 GS/s acquisition while also having two channels with 70 GHz, 200 GS/s performance suitable for next-generation designs. Subsequently, two additional units can be added for a total of four channels at 70 GHz, 200 GS/s. Units in this four-unit configuration can be separately deployed as pairs or standalone units at any time to meet other test demands.

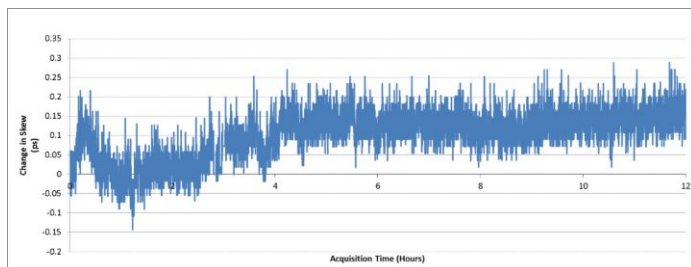
The DPO77002SX also offers a unique value proposition in single-channel 70 GHz, 200 GS/s applications such as RF analysis or pulsed laser studies. In these cases a user can purchase a single unit for 70 GHz channel performance along with two channels at 33 GHz. Additional units can be purchased at a later time and combined using UltraSync if higher channel count is needed.

The following multi-unit configurations are supported:

- 2 DPO77002SX: 2 Ch @ 70 GHz, 200 GS/s or 4 Ch @ 33 GHz, 100 GS/s
- 4 DPO77002SX: 4 Ch @ 70 GHz, 200 GS/s or 8 Ch¹ @ 33 GHz, 100 GS/s
- 2 DPO75902SX: 2 Ch @ 59 GHz, 200 GS/s or 4 Ch @ 33 GHz, 100 GS/s
- 4 DPO75902SX: 4 Ch @ 59 GHz, 200 GS/s or 8 Ch¹ @ 33 GHz, 100 GS/s
- 2 DPO75002SX: 2 Ch @ 50 GHz, 200 GS/s or 4 Ch @ 33 GHz, 100 GS/s
- 4 DPO75002SX: 4 Ch @ 50 GHz, 200 GS/s or 8 Ch¹ @ 33 GHz, 100 GS/s
- 2 DPO73304SX: 4 Ch @ 33 GHz, 100 GS/s or 8 Ch¹ @ 23 GHz, 50 GS/s
- 4 DPO73304SX: 8 Ch¹ @ 33GHz, 100GS/s or 16 Ch¹ @ 23GHz, 50GS/s
- 2 DPO72304SX: 4 Ch @ 23 GHz, 100 GS/s or 8 Ch¹ @ 23 GHz, 50 GS/s
- 4 DPO72304SX: 8 Ch¹ @ 23GHz, 100GS/s or 16 Ch¹ @ 23GHz, 50GS/s

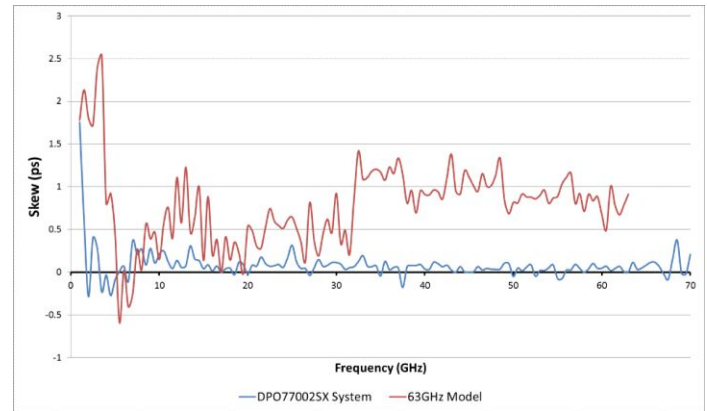
Skew Stability

UltraSync provides outstanding integration and time alignment between units in a multi-unit stack. Once channels have been deskewed in a multi-unit stack, skew is very stable over time and temperature. The specification for skew stability is $\leq 250 f_{S_{RMS}}$. The following DPO77002SX skew measurement plot shows that even when including the startup temperature stabilization period (approximately 1 hour), the pk-pk variation is about 400 fs, and is about 350 fs pk-pk after the 1-hour warm-up period. This plot also shows exceptional consistency over this 12-hour data collection.



Change in channel-to-channel skew of DPO77002SX system over time.

Another important aspect of skew is how the phase relationship between two channels varies with changing frequency (group delay effects). The following plot compares the performance of a DPS77004SX 70 GHz two-unit system against the performance of another vendor's 63 GHz frequency-interleaved channels. What you see here is that the UltraSync two-channel skew performance dramatically surpasses the performance of another vendor's single 63 GHz model containing two channels.



Channel skew vs. Frequency comparison between DPO77002SX system and other vendor's 63 GHz model.

Short signal path

Minimizing input signal path length is especially important when working at 70 GHz ultra-high bandwidth. The compact nature of DPO70000SX creates more versatile mounting options when co-locating instrument and device under test (DUT). Options such as the Auxiliary Front Panel and Remote Desktop connection allow further flexibility by eliminating the need for direct access to the instrument front panel once connected. As a result, the SX series enables the broadest range of options when dealing with a variety of DUT configurations as compared to classic bench instruments.

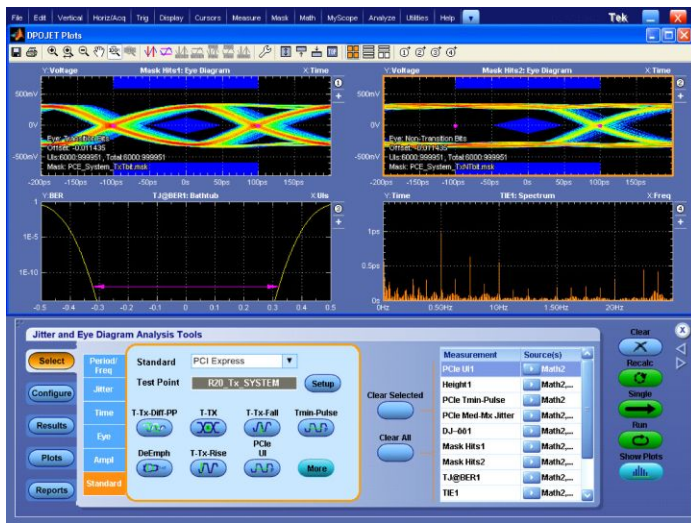
Input signal path length may be minimized in multi-unit configurations by inverting one unit of a pair. The low, central location of the 70 GHz ATI input provides very small input connector spacing when operating units in this configuration.

Instruments can also be arranged at various angles to suit DUT layout, such as at right angles for card-and-backplane situation or face-to-face around a small DUT. Layouts such as this create the shortest input signal path and maximize SNR. In addition, effects of signal path elements such as cables and adapters can be characterized and removed using the Serial Data Link Analysis application to obtain the best analysis results and insight.

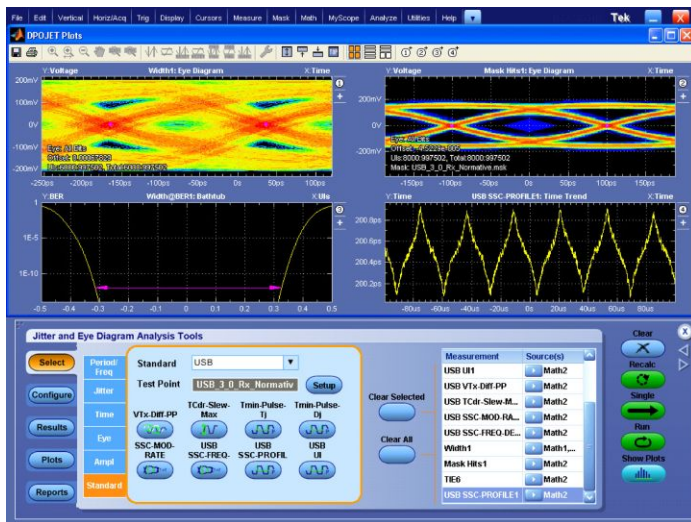
¹ Maximum of 4 channels displayed on-screen. Access to additional channels data available through program interface.

Applications

Enterprise computing



PCI Express® Transmitter Compliance and Debug (Option PCE3 and PCE4) – Analyze the performance of your PCI Express® Gen 1, 2, 3, or 4 design with comprehensive test support. Using DPOJET, Option PCE3 and PCE4 enable tests that conform to PCI-SIG standards.



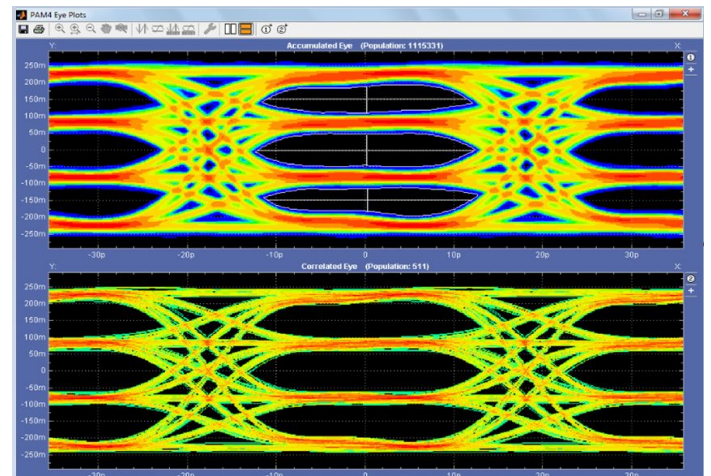
USB 3.0 Transmitter Test Solution (Option USB3) – Perform verification, characterization, and debug of USB 3.0 devices. Measurements are implemented in DPOJET and are compliant to the USB 3.0 specification. For compliance and automation, USB-TX is available.

Datacom measurements

PAM4 and NRZ measurements – The throughput of Datacom networks continues to increase. Tek's DPO7000SX is ready to perform standards validation for today's 25/28 G industry standards and beyond (see chart below). The powerful combination of DPO7000SX, DPOJET Jitter and Noise Analysis, and the SDLA Serial Data Link Analysis tool performs accurate de-embedding and eye diagram analysis for these key Datacom standards. The 50 GHz to 70 GHz models provide ample bandwidth for Bessel-Thomson filter responses.

Datacom standards	Recommended bandwidth	Tektronix scope model
Ethernet 10GBASE KRn 100GBASE KR-4, CR-4 25 Gb Phy KR, CR for 100G	25 GHz 59 GHz 59 GHz	DPO72504DX DPS75904SX DPS75904SX
Fibre Channel 16Gb 32Gb	30 GHz 45 GHz	DPS75004SX DPS75004SX
Infiniband EDR 25Gb	50 GHz	DPS75004SX
OIF-CEI 3.0 CEI-25G	70 GHz	DPS77004SX
OIF-CEI 3.1 CEI-56G (PAM4) CEI-56G (NRZ)	70 GHz 70 GHz	DPS77004SX DPS77004SX

With 400 G networking, serial data transmission speeds are now reaching 56 Gb/s per channel, making NRZ signaling techniques less practical. The bandwidth efficient PAM4 (4-level pulse amplitude modulation) signaling is being widely used to achieve this new performance level. Accurate PAM4 validation is best conducted using the DPO7000SX Series, with its industry-leading low-noise ATI technology, to achieve the best test margin on your measurement results. For analysis of PAM4, the DPO7000SX Option PAM4 combines industry leading equalization tools and a robust built-in software based clock recovery, which is essential to recovering complex timing and performing analysis of high ISI PAM4 signals.



Option PAM4 offers electrical measurements and option PAM-O offers optical measurements. Both comply with IEEE and OIF specifications. Optical interfacing is provided through the use of the DPO70E Series optical probes, which include ORR filters.



Tektronix TekExpress 100G Tx Test Report CAUI4-TX (TP1a)

Setup Information		Master Scope Information	
DUT ID	DuT001	Master Scope Information	DPO778025K_PQ1 86011
Date/Time	2016-04-19 10:44:55	Master Scope F/W Version	10.2.0
TekExpress Version	100GTX 8.0.0.128 Framework 4.0.5.248	Master Scope SPC Status	PASS
Specification Version	IEEE 802.3bm, Annex 83E.3.1	Extension-1 Scope Information	DPO778025K_PQ1 86011.2
Compliance Mode	True	Extension-1 Scope F/W Version	10.2.0
Execution Mode	Live	Extension-1 Scope SPC Status	PASS
Overall Test Result	Pass		
Overall Execution Time	0:11:17		
DUT COMMENT	100G Tx CAUI4		

Test Name Summary Table

Test Name	Result
DC Common Mode Output Voltage	Pass
CRP Peak to Peak Output Voltage -Tx Disabled	Pass
CRP Peak to Peak Output Voltage -Tx Enabled	Pass
AC Common Mode Output Voltage	Pass
Single Ended Output Voltage	Pass
Signaling Rate	Pass
Eye Width	Pass
Eye Height Differential	Pass
Transition Time(20% to 80%)	Pass

TekExpress 100G Tx - (Untitled)*

DUT ID: DUT001

Acquire live waveforms Use pre-recorded waveform files

View: Compliance

Standards	Test Points	Specification
CAUI4	TP1a	IEEE802.3bm, Annex 83E.3.1
KR4	TP1a	IEEE802.3bj Section 93
CR4	TP2	IEEE802.3bj Section 92

Data Rate: 25.78125 Gbps

Source: Differential Single Ended

IEEE 802.3bj (KR4/CR4) and IEEE 802.3bm (CAUI4) Electrical Real Time Transmitter Compliance and Characterization Solution (option 100G-TXE) - TekExpress 100G-TXE automation provides turnkey testing and debug of 100G Ethernet's three most common electrical interfaces. Tools for 100G- KR4/CR4/CAUI4 are brought together in a single 100G-TXE option to support silicon designers and system designers as they perform KR4 and CR4 validation.

TekExpress 100G Tx - (Untitled)*

Overall Test Result: Pass

Test Name	Details	Pass/Fail	Lane	Value	Units	Margin
AC Common Mode Output Voltage	AC Common Mode	<input checked="" type="checkbox"/> Pass	Lane0	8.07210	mV	H:3.9279
Signaling Rate	Signaling Rate	<input checked="" type="checkbox"/> Pass	Lane0	25.78128	Gbd	L:0.0025 H:0.0025
Linear Fit Pulse Peak	Linear Fit Pulse Peak	<input checked="" type="checkbox"/> Pass	Lane0	0.35740	V	L:0.0576
Signal To Noise And Distortion Ratio	Signal To Noise And Distortion Ratio	<input checked="" type="checkbox"/> Pass	Lane0	27.84844	dB	L:0.8484
Steady State Voltage	Steady State Voltage	<input checked="" type="checkbox"/> Pass	Lane0	0.42219	V	L:0.0222 H:0.1778
Even-Odd Jitter Peak to Peak	Even-Odd Jitter Peak to Peak	<input checked="" type="checkbox"/> Pass	Lane0	0.00840	UI	H:0.0266
Effective bounded uncorrelated jitter peak to peak	Effective bounded uncorrelated jitter peak to peak	<input checked="" type="checkbox"/> Pass	Lane0	0.00674	UI	H:0.0933
Effective total uncorrelated jitter peak to peak	Effective total uncorrelated jitter peak to peak	<input checked="" type="checkbox"/> Pass	Lane0	0.03682	UI	H:0.1432
DC Common Mode Output Voltage	DC Common Mode Output	<input checked="" type="checkbox"/> Pass	Lane0	1.00000	V	L:1.0000 H:0.9000

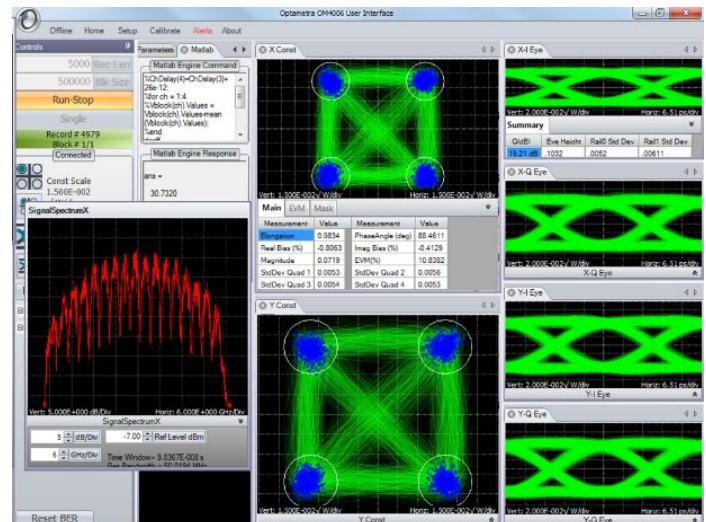
Completed.

Coherent optical

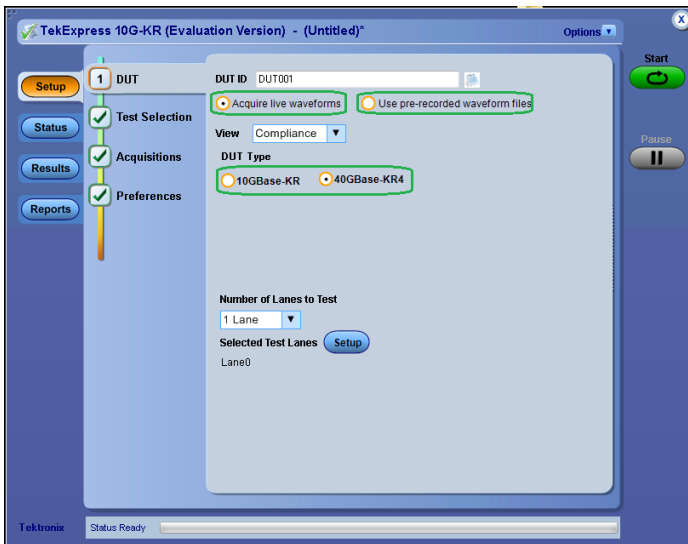
Coherent optical modulation analysis

Tektronix DPO70000SX oscilloscopes are ideal for modulation format analysis of 400 Gb/s and Terabit-based coherent optical networking systems. The unique architecture enables scalability to grow instrument performance by adding channels or more bandwidth; test 100 G cost effectively now and expand into 400 G or 1 Terabit later. The DPO70000SX low profile reduces concerns of signal loss in system connectivity on your coherent measurements by placing the Optical Receiver as close as possible to the instrument's input channel.

More accurate modulation analysis starts with a lower Error Vector Magnitude (EVM) floor in the instrument. The DPO70000SX Oscilloscope utilizes ATI technology to provide the industry's lowest noise floor supporting these measurements. In addition, the system is achieving four channels of full 70 GHz Bandwidth at 200 GS/s per channel, providing a very rich analysis environment. When used in conjunction with the OM4524 Optical Modulation Receiver, optical system research engineers can customize their DSP analysis and visualization for non-standard modulation techniques using easy customer-specific implementations with extensive customizable analysis SW that leverages Matlab™.



- 70 GHz Bandwidth on 4 Channels for 1 Terabit/s systems
- Industry-best lowest noise for low EVM
- 200 GS/s sampling on 4 channels for phase tracking
- Compact form factor with scalability for channel & bandwidth
- Customizable DSP for unique analysis needs

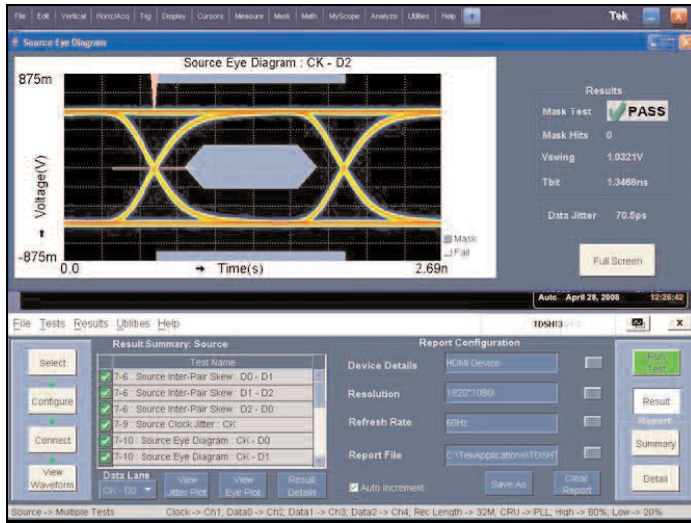


10GBASE-KR/KR4 Compliance and Debug Solution (Option 10G-KR) - Automated compliance measurements for IEEE 802.3ap-2007 specifications. This option includes an automated compliance solution and debugging with DPOJET. The automated test setup measures transmitter equalization levels generating 12 results for each tap and 120 results for 9 different measurements in approximately 15 minutes.

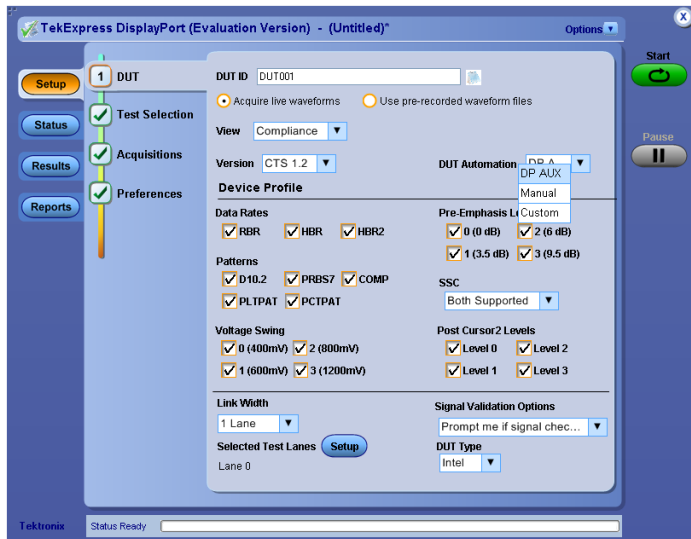


Tektronix SFP+ QSFP+ Tx - is developed on a Real Time Oscilloscope platform, which is the platform of choice for engineers designing their products around SFF-8431 & SFF-8634 technology. Option SFP-TX and SFP-WDP enable both an Automation Solution (for Compliance) and DPOJET Option (for Debug). Users can save up to 80% on testing time compared to manual testing. TWDPC - Transmitter Waveform Distortion Penalty for Copper Measurements are available with Option SFP-WDP. SFF-8431 SFP+ TWDPC based Matlab code is integrated into the SFP-WDP option to make sure Engineers can use this measurement in the automated setup.

Display

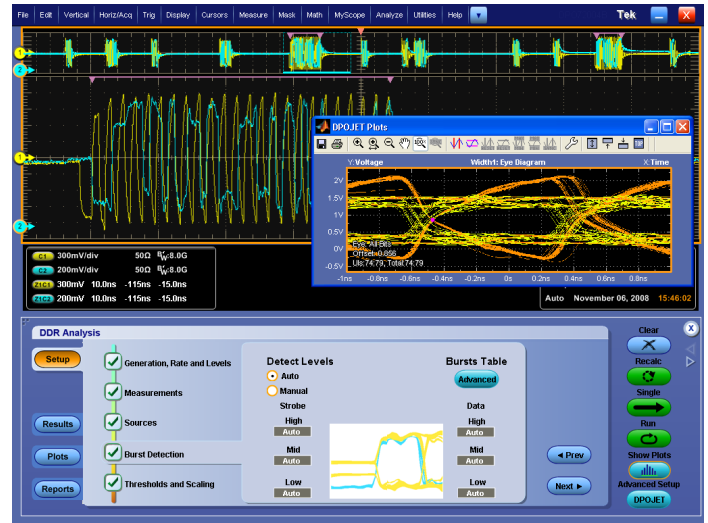


HDMI Compliance Test Solution (Option HT3) – A fast, efficient solution for HDMI compliance measurement challenges, no matter if you are working on a Source, Cable, or Sink solution. This application provides all the HDMI compliance test solutions you need to ensure quality and interoperability.



DisplayPort Compliance Test Solution (Option DP12) – Supports DisplayPort Compliance Test Standard (CTS) source test with four-line simultaneous testing using the Tektronix® P7300SMA Series probes and DisplayPort software. Detailed test reports with waveform plots, pass/fail results, and margin analysis are included.

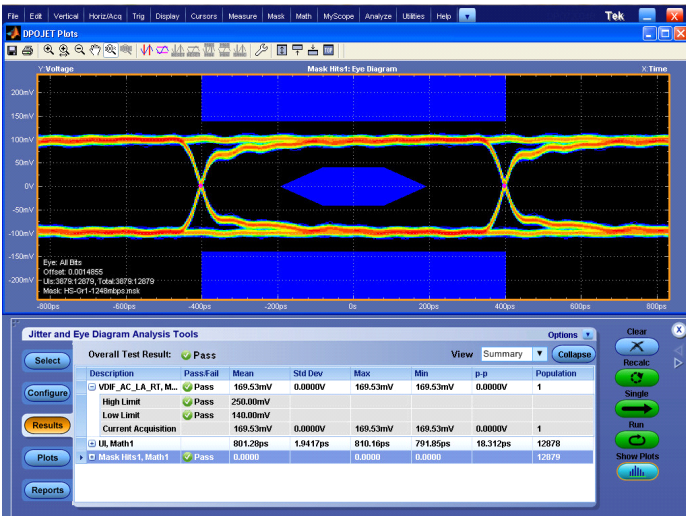
Mobile computing



DDR Memory Bus Analysis (Option DDRA) – Automatically identifies DDR1, LPDDR, LPDDR2, LPDDR3, DDR2, DDR3, DDR4, and GDDR3 Reads and Writes and makes JEDEC conformance measurements with pass/fail results on all edges in every Read and Write burst. DDRA provides capabilities for measurements of clock, address, and control signals. In addition to enabling conformance testing DDRA with DPOJET is the fastest way to debug complex memory signaling issues.



MIPI® D-PHY Characterization and Analysis Solution (Option D-PHY) – Verify to the D-PHY specification by rapidly characterizing and discovering sources of jitter and signal integrity concerns using the fully flexible and customizable test setup. Using DPOJET, Option D-PHY enables transmitter high-speed data-clock timing measurements, along with a full range of electrical characteristics in high-speed or low-power modes.



MIP® M-PHY Debug, Analysis, Characterization and Conformance Test Solution (Option M-PHY) – Verify to the M-PHY specification by rapidly characterizing and discovering sources of jitter and signal integrity concerns. Using DPOJET, Option M-PHY enables transmitter signaling and timing measurements such as differential transmit eye diagrams, rise and fall times, slew rate, amplitude parameters, common mode voltages on each lane for both the large and small amplitude configurations, as well as the terminated and unterminated cases.

RF

With its low noise and flat frequency response to 70 GHz, the DPO7000SX opens opportunities for measurement and analysis of wideband RF signals.

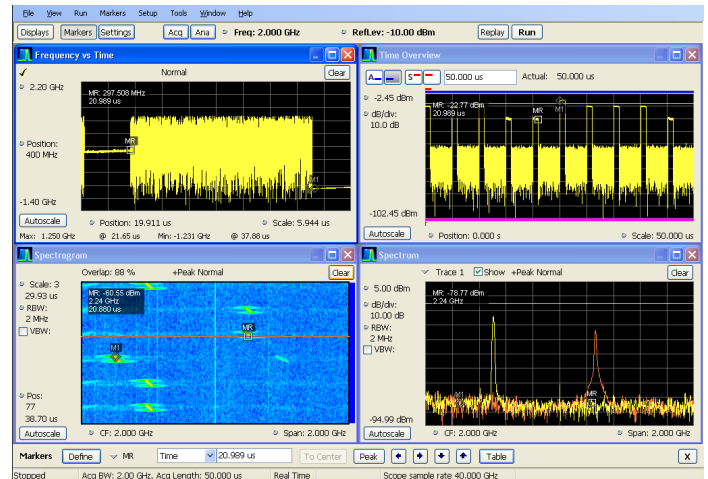
SignalVu® vector signal analysis – When vector signal analysis of RF or baseband signals are needed, the optional SignalVu application enables measurements in multiple domains (frequency, time, phase, modulation) simultaneously. SignalVu measurements are fully correlated with the scope's time domain acquisition and triggering. Time domain events, such as commands to an RF subsystem, can be used as trigger events, while the subsystem's RF signal can be seen in the frequency domain.

In addition to spectrum analysis, spectrograms display both frequency and amplitude changes over time. Time-correlated measurements can be made across the frequency, phase, amplitude, and modulation domains. This is ideal for signal analysis that includes frequency hopping, pulse characteristics, modulation switching, settling time, bandwidth changes, and intermittent signals.

SignalVu can process RF, I and Q, and differential I and Q signals from any oscilloscope inputs. Math functions applied by the oscilloscope are also used by SignalVu allowing users to apply custom filtering prior to vector signal analysis.

The Microsoft Windows environment makes the use of this multi-domain analysis even easier with an unlimited number of analysis windows, all time-correlated, to provide deeper insight into signal behavior. With a user interface that adapts to your preferences (keyboard, front panel, touch screen, and mouse), SignalVu is easy to apply for both first-time users and experienced hands.

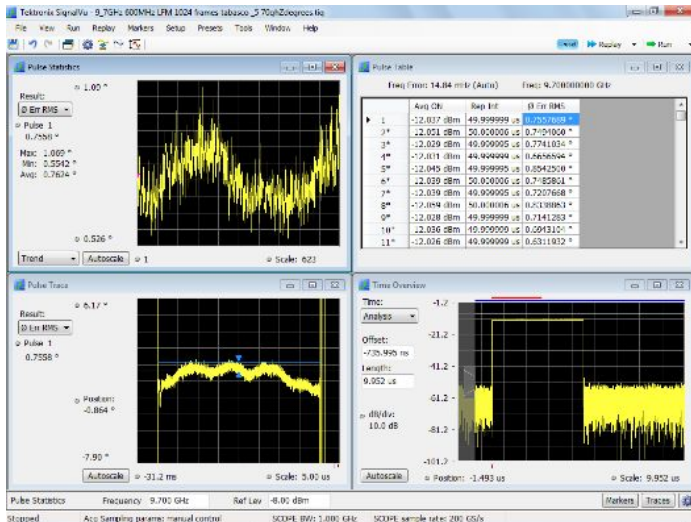
Time-correlated, multi-domain view provides a new level of insight into design or operational problems not possible with conventional analysis solutions. Here, the hop patterns of a narrowband signal can be observed using Spectrogram (lower left) and its hop characteristics can be precisely measured with Frequency vs Time display (upper left). The time and frequency responses can be observed in the two right-hand views as the signal hops from one frequency to the next.



Radar and high frequency-based analysis – The low-noise, high bandwidth DPO7000SX Series Oscilloscope is ideal for high frequency FFT-based measurement analysis. When combined with the powerful SignalVu software analysis option, the DPO7000SX instrument provides FFT (fast fourier transform) measurement capability up to 70 GHz. With its scalable instrument architecture, RF engineers can obtain a single channel unit for RF input-only measurements and grow to multi-unit configurations for comprehensive RF system validation.

Examples of high-frequency RF measurements with the DPO7000SX include:

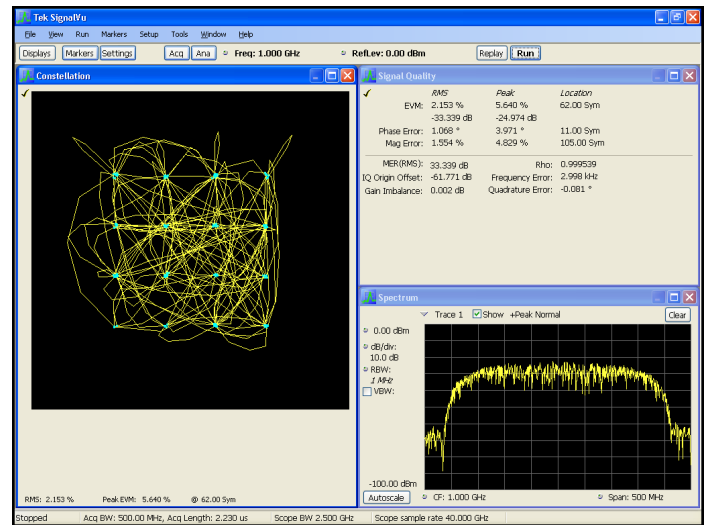
- Chirp Linearity measurements on Radar signals (see below figure)
- Wireless measurements on IEEE802.11ad e.g. (60.48 GHz carrier frequency)
- Monitor & debug satellite communications over K-Band (20-40 GHz)



Once low-noise waveform data is captured by the 70 GHz DPO7000SX, SignalVu can be used to demodulate the signal, and display a constellation diagram and Error Vector Magnitude (EVM) measurement and other needed measurements. SignalVu also provides detailed analysis in multiple domains as additional options, such as pulse analysis and settling time for Radar systems work, digital modulation analysis and flexible OFDM analysis for emerging modulation standards, as well as AM/FM/PM modulation and audio measurements for lower bandwidth requirements.

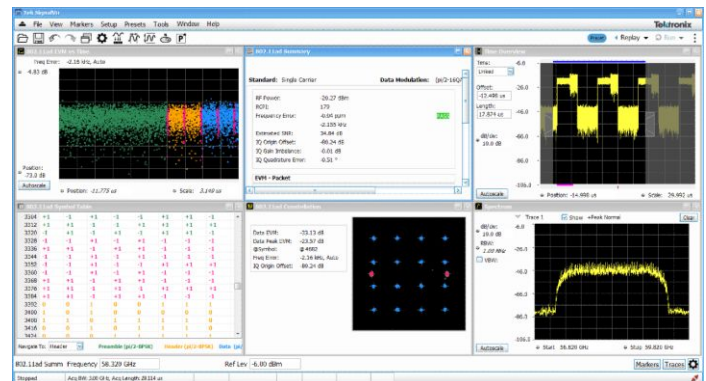
- Industry-low noise enables low EVM floor
- 70 GHz provides wide dynamic range and accurate chirp linearity
- Integrated FFT & Phase Plot creation provides fast, accurate frequency domain measurements

Options tailored for your wideband applications – SignalVu vector signal analysis software offers options to meet your specific application, whether it be wideband radar characterization, broadband satellite, or spectrum management. SignalVu Essentials (Opt. SVE) provides the fundamental capability for all measurements and is required for pulse analysis (Opt. SVP), settling time (Opt. SVT), digital modulation analysis (Opt. SVM), flexible OFDM analysis (Opt. SVO), and AM/FM/PM Modulation and Audio Measurements (Opt. SVA). Wideband satellite and point-to-point microwave links can be directly observed with SignalVu analysis software.



General Purpose Digital Modulation Analysis (Opt. SVM) used to demodulating a 16QAM backhaul link running at 312.5 MS/s.

WiGig IEEE802.11ad transmitter testing – Option SV30 provides WiGig IEEE802.11ad standard transmitter measurements. Used together with the DPO77002SX, it delivers industry's best accurate signal quality measurement at 60 GHz. It allows you to automatically detect the packet start, synchronize to preamble using the Golay codes in the short training field and demodulate preamble, header, and payload separately. These different fields are color coded in the user interface. This option also measures EVM in each of the packet fields per the standard, and decodes the header packet information. In addition RF power, Received Power Indicator, Frequency error, IQ DC origin offset, IQ Gain and Phase imbalance are reported in the Summary display. Pass/Fail results are reported using customizable limits and the presets make the test set-up push-button. Both Control PHY and Single Carrier PHY are supported and the measurements listed above can be done at RF or at IF. For further insight into the signal, you can also visualize the EVM spread across the analyzed packet with color codes differentiating fields and color coded demodulated symbols in tabular form with an option to traverse to the start of each field for easier navigation.



DPO77002SX with SV30 provides industry best EVM accuracy, it allows easy setup to perform transmitter measurements including time overview of the bursts, spectrum, constellation diagram, decoded burst information and EVM measurements.

WiGig 802.11ad (Opt. SV30)

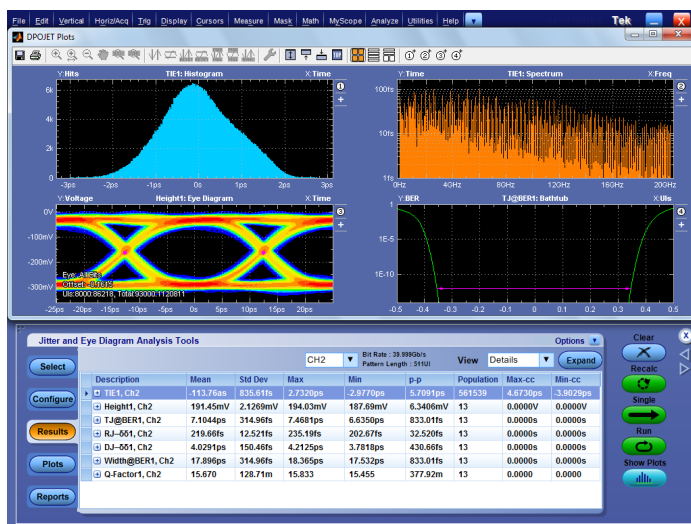
Modulation formats	Control PHY (DBPSK), Single Carrier PHY ($\pi/2$ BPSK, $\pi/2$ QPSK, $\pi/2$ 16QAM)
Measurements and displays	RF output power, Received Channel Power Indicator (RCPI), Frequency Error, Symbol Rate Error, IQ Origin Offset, IQ Gain Imbalance, IQ Quadrature Error, EVM results for each packet region (STF, CEF, Header and Data). Packet information includes the Packet type, Preamble, Synchronization Word or Access Code, Packet Header, Payload length, and CRC details.
Residual EVM, measured at RF (58 GHz to 65 GHz) on DPO770002SX ²	$\pi/2$ BPSK = 1.9% $\pi/2$ QPSK = 2.1% $\pi/2$ 16QAM = 2.5%

Advanced analysis

DPOJET Comprehensive Jitter and Noise Analysis

DPOJET provides engineers the highest measurement sensitivity and accuracy available in real-time instruments. With comprehensive jitter and eye-diagram analysis and decomposition algorithms DPOJET simplifies discovering signal integrity concerns and jitter and their related sources in today's high-speed serial, digital, and communication system designs.

To support measurement on signals acquired with the DPO70E1 optical probe, DPOJET now also provides optical measurements. These include Extinction Ratio (ER), Optical Modulation Amplitude (OMA), Optical High value, and Optical Low value.



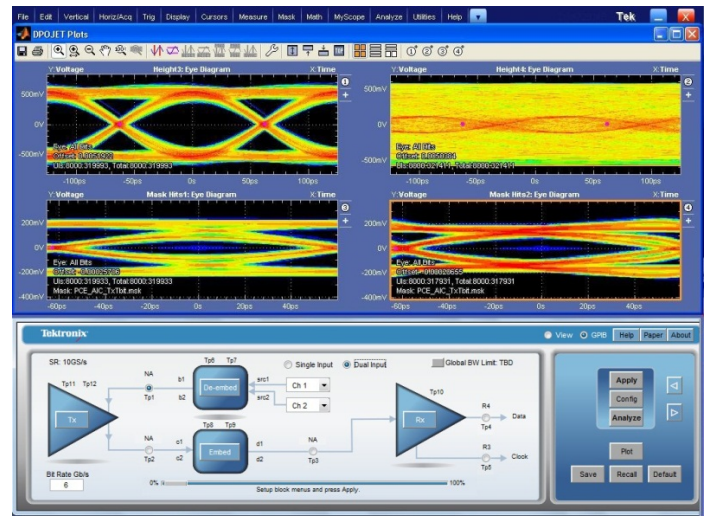
DPOJET Jitter and Eye Diagram Analysis - Simplify identifying signal integrity issues, jitter, and their related sources.

Noise analysis with DPOJET (Opt. DJAN)

Jitter essentials, advanced analysis and custom extensions – DPOJET Essentials is standard on the DPO70000SX Series with the DPOJET advanced version available as an option. Application-specific measurement packages are also available that extend DPOJET and perform the extensive set of tests required by industry standard groups.

SDLA signal path de-embed and custom filters

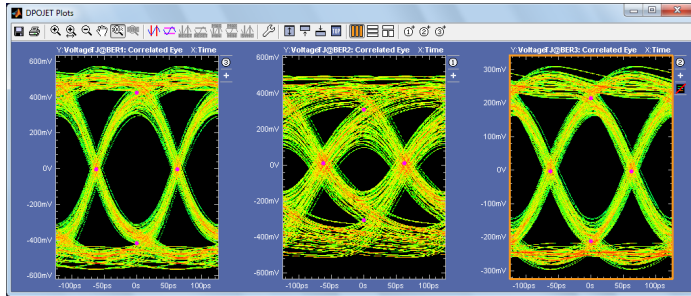
Acceleration of signaling speeds and shrinking geometries create several challenges for next generation multi-gigabit designs and test methodologies. Designs are evolving to address these challenges with advanced equalization techniques at the transmitter and receiver. Smaller form factors make signal access more difficult, resulting in non-ideal probing points. This can lead to loss and reflections on the acquired signal due to impedance discontinuities that are not present at the ideal measurement location. The advanced techniques employed by the designs call for advanced measurement solutions. The challenge begins with the signal acquisition; capturing a signal through cables, probes and fixtures distort the signal shape. SDLA Visualizer allows you to de-embed the effects (reflections, insertion loss, and cross coupling) of the measurement circuit (cables, probes, and fixtures) from the waveform while taking into account the transmitter output and receiver input impedance. De-embedding these effects improves the accuracy of measurements and can make the difference between passing or failing a test.



Signal path equalization – Using the optional Serial Data Link Analysis Visualizer (SDLA64) application, you can gain further insight into serial data links with the capability to emulate the serial data channel from its S-parameters, remove reflections, cross-coupling, and loss caused by fixtures, cables, or probes, and open closed eyes caused by channel effects using receiver equalization techniques, such as CTLE, DFE, FFE. IBIS-AMI models for silicon-specific receiver equalization can be used to observe on-chip behavior.

² Measurement uncertainty: ± 0.3% due to pre-compensation filter

The eye diagrams below illustrate the correlated eye of a signal before a channel, after a channel, and after equalization. Eye closure due to channel effects have effectively been removed using SDLA and in this case the eye widths are within ~3 ps as shown in the eye diagram on the left and right hand sides.

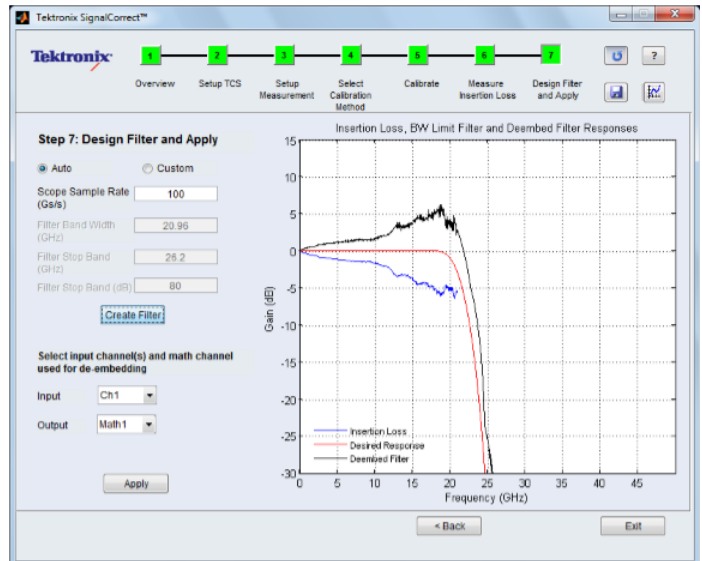


Custom filters – Create your own filters or use the filters provided standard with the DPO70000SX Series to enhance your ability to isolate or remove a component of your signal (noise or specific harmonics of the signal). These customizable FIR filters can be used to implement signal-processing techniques, such as removing signal pre-emphasis or minimizing the effects of fixtures and cables connected to the device under test.

SignalCorrect™ software and TCS70902 Calibration Source



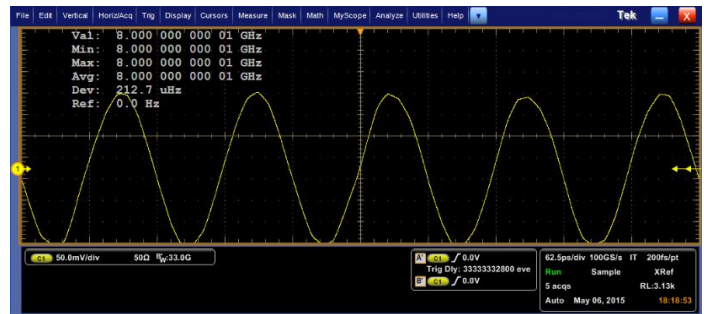
SignalCorrect allows quick characterization of cables, fixtures and other types of interconnects using the TCS70902 fast step source and the response captured on a DPO70000SX Series real-time oscilloscope.



SignalCorrect creates a filter that you can apply to your oscilloscope inputs to de-embed your device or interconnect under test.

Counter timer

The high resolution counter/timer is a new optional feature that is made possible by the new trigger system in the DPO70000SX series oscilloscopes. This is a precision frequency counter which provides frequency analysis up to 25 GHz, with up to 13 digits of resolution and 12 digits/second. Using the internal clock, this counter is accurate to better than 1 ppm. Higher accuracy is possible using a high precision external clock source. Because this measurement is made through the trigger system, it measures each and every cycle of the signal on a continuous basis during the trigger gate time, rather than making measurements on finite blocks of data through the normal acquisition channel.



This feature provides the ability to make highly accurate clock stability measurements. In the screen capture shown, a deviation of 212 μHz of source wander is measured on an 8 GHz precision source. In this figure, the signal generator was set to 8.0000000001 GHz, and the scope measured precisely that amount.

The timer allows precise measurements between trigger events with a 200 fs resolution, and can include time measurements from an A event to a B event, where A and B events can be any valid trigger mode (e.g. Glitch, Runt, Edge, etc). This feature is useful for measuring propagation delays, or analyzing anomaly occurrence rates.

Three important distinctions between this counter/timer and conventional counter/timers are:

- > 25 GHz analog bandwidth
- Wide selection of high bandwidth scope probes available for the highest signal fidelity connection to the DUT
- Ability to view the waveform on-screen to insure the counter/timer is seeing a valid waveform, and that trigger levels are set appropriately for the waveform

Built-in analysis system

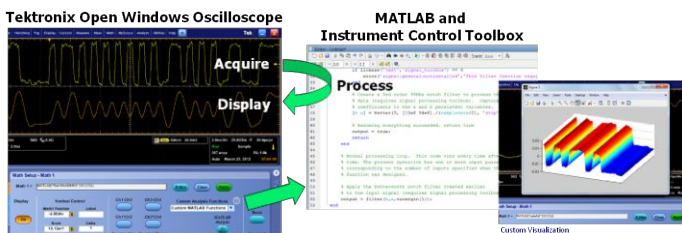
DPO7000SX includes a wide variety of built-in features for visualizing and measuring signal behaviors. Select from 54 automatic measurements using a graphical palette that logically organizes measurements into Amplitude, Time, Histogram, and Communications categories. Gather further insight into your measurement results with statistical data such as mean, min, max, standard deviation, and population.

Define and apply math expressions to waveform data for on-screen results in terms that you can use. Access common waveform math functions with the touch of a button. Or, for advanced applications, create algebraic expressions consisting of live waveforms, reference waveforms, math functions, measurement values, scalars, and user-adjustable variables with an easy-to-use calculator-style editor.

With deep acquisition memory, margin testing can be done over many cycles and long duration trends in the data can be observed. Plus, data from the oscilloscope can be captured into Microsoft Excel using the unique Excel toolbar, and formatted into custom reports using the Word toolbar provided with the DPO7000SX Series.

Custom math expressions with MATLAB

Tektronix custom math expressions with MATLAB enable users to create MATLAB scripts that process live waveform data and return results into scope math traces. Extensions can also use MATLAB features to create specialized analysis and visualizations.



Debugging

Throughout the design cycle, DPO7000SX Series oscilloscopes provide the ability to debug malfunctioning subsystems and isolate the cause. With the high waveform capture rate of FastAcq[®] you can quickly identify signal anomalies that occur intermittently - saving minutes, hours, or even days by quickly revealing the nature of faults so sophisticated trigger modes can be applied to isolate them. Using Pinpoint[®] triggers, infrequent events such as glitches or signal runts caused by bus contention or signal integrity issues can be captured, analyzed, and then eliminated.

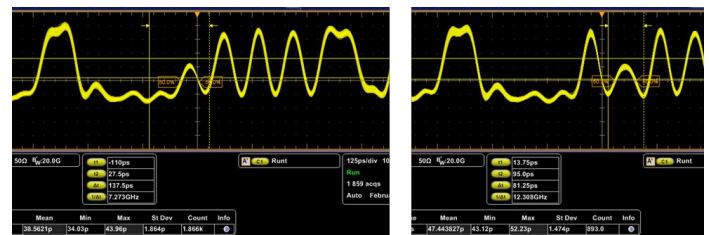
FastAcq[®] expedites debugging by clearly showing imperfections

More than just color grading or event scanning, the FastAcq proprietary DPX[®] acquisition technology captures signals at more than 300,000 waveforms per second on all TekConnect[®] channels³ simultaneously, dramatically increasing the probability of discovering infrequent fault events. And with a simple turn of the intensity knob you can clearly "see a world others don't see", displaying the complete picture of your circuit's operation. Some oscilloscope vendors claim high waveform capture rates for short bursts of time, but only DPO7000 Series oscilloscopes, enabled by DPX technology, can deliver these fast waveform capture rates on a sustained basis.

Pinpoint[®] trigger

Whether you're trying to find a problem signal or need to isolate a section of a complex signal for further analysis, Tektronix Pinpoint triggering provides the solution. Pinpoint triggering allows selection of virtually all trigger types on both A and B trigger events delivering the full suite of advanced trigger types for finding sequential trigger events. Pinpoint triggers provide trigger reset capabilities that begin the trigger sequence again after a specified time, state, or transition so that even events in the most complex signals can be captured.

The DPO7000SX Series provides the highest trigger system performance available in a real time scope. The figure shows triggering on <50 ps bit-wide runt pulses (fails to cross both thresholds within specified time) on 25.78 GBaud (100GbE) signaling. High system bandwidth and extreme trigger timer precision enable reliable capture of signal aberrations and efficient isolation of fault conditions.

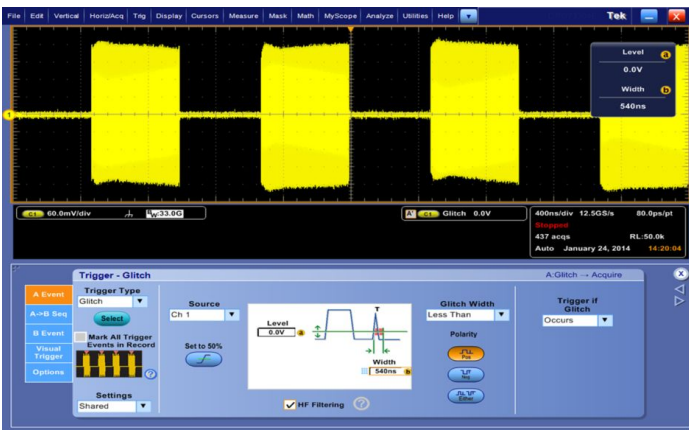


In the next figure, pulse width discrimination is used to isolate pulses >40 ps and <60 ps wide, showing reliable capture of 50 ps pulses within a 20 Gbps PRBS11 sequence.

³ FastAcq not available on ATI channels.



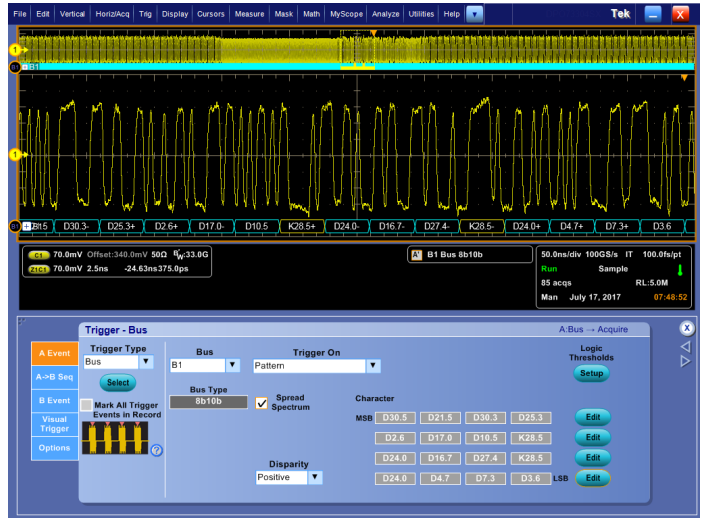
DPO70000SX includes a unique Envelope trigger mode that enables direct triggering on the envelope of a modulated carrier. Edge, Width and Timeout trigger types can be applied to a detected envelope to provide stable trigger on modulated bursts or discriminate bursts of a specific width. Carrier frequency can range from 500 MHz to 20 GHz to address a broad range of applications. The figure illustrates triggering on burst of specific width.



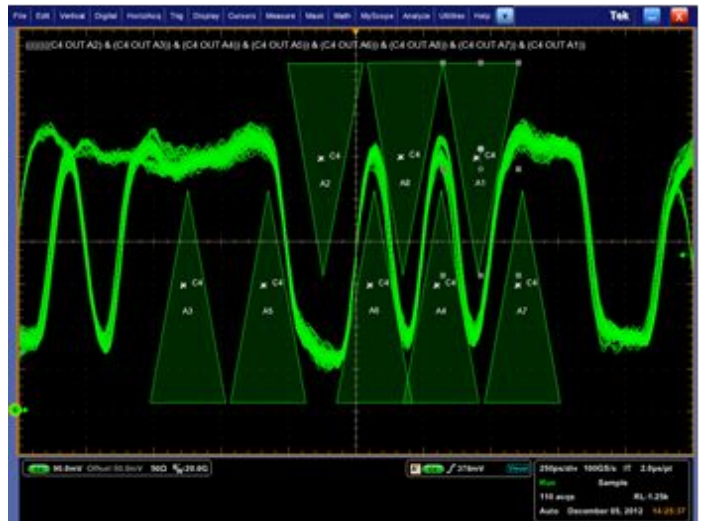
Hardware serial pattern triggering – To verify serial architectures, the serial pattern triggering option for 8b10b NRZ serial data streams with built-in clock recovery provides the ability to correlate events across physical and link layers. The instrument can recover the embedded clock signal, identify transitions, and allow you to set the desired encoded words for a specific serial pattern trigger to be captured. This feature is included with the DSAX option bundle, or can be ordered separately as the ST14G option to the instrument. This 8b10b serial trigger option provides performance from 600 Mbps to 14.1 Gbps, and provides bit level or character level decoding. Any active input channel can be used as a source for the hardware serial trigger.

The 160 bit (16 character) pattern match feature allows the oscilloscope to reliably trigger on a specific section of a serial data sequence, thereby facilitating diagnostic and debug work by isolating portions of the serial data stream.

In addition, the hardware serial trigger feature is designed for reliable operation even in the presence of spread spectrum clocks with a range of 0-5000 pps downspread.



Visual trigger – Visual Trigger further extends the Pinpoint Triggering's capabilities, adding another level of trigger qualification to find important events in a wide variety of complex signals. Visual Trigger qualifies Pinpoint triggers by scanning through all waveform acquisitions and comparing them to on-screen areas (geometric shapes). Up to eight areas can be created using a mouse or touchscreen, and a variety of shapes (triangles, rectangles, hexagons, or trapezoids) can be used to specify the desired trigger behavior. Once shapes are created, they can be edited interactively to create ideal trigger conditions



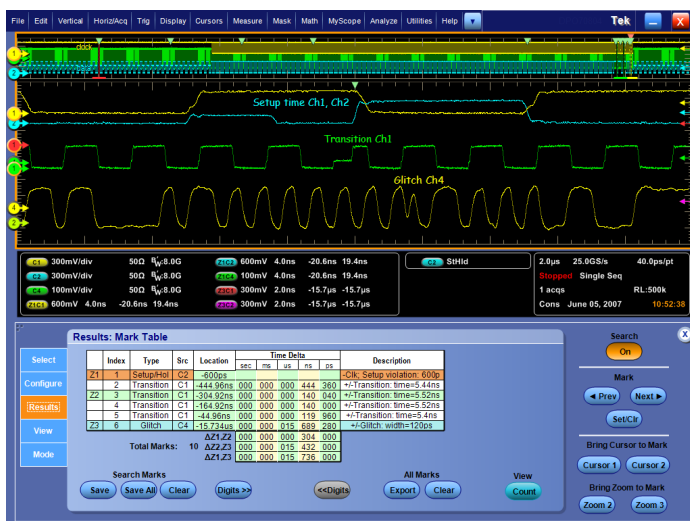
FastFrame™

When the key events you are interested in are widely spaced in time, such as bursts of activity on a bus, the FastFrame segmented memory feature on the DPO7000SX Series enables you to capture the events of interest while conserving acquisition memory. Using multiple trigger events, FastFrame captures and stores short bursts of signals and saves them as frames for later viewing and analysis. Capturing thousands of frames is possible, so long-term trends and changes in the bursting signal can be analyzed. FastFrame also minimizes trigger re-arm time, allowing for acquisition of events that are very closely spaced in time. Using this feature, it is possible to reliably acquire signals that are spaced by only a few microseconds.

Extended features that are part of FastFrame include the ability to very efficiently calculate a point-point average of all frames to a single waveform (summary frame). In addition, it is possible to perform an orthogonal average, whereby multiple sets of frames can be acquired. In this mode, each #1 frame is averaged on a point-by-point basis with all other #1 frames, each #2 frame is averaged on a point-by-point basis with all other #2 frames, and so on up to the total number of frames specified. This feature provides a very efficient way to extend the dynamic range of the oscilloscope while acquiring repeatable sequences of events.

Advanced search and mark

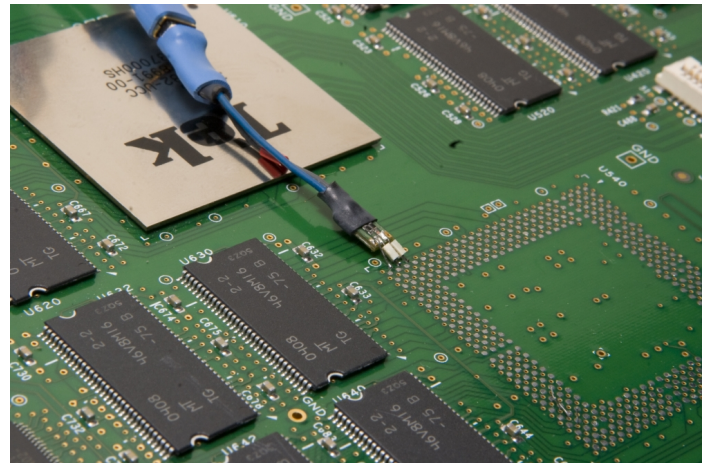
Isolating the key event causing your system failure can often be a tedious task. With the Advanced Event Search and Mark feature standard on the DPO7000SX Series, examining data and highlighting important events, skipping the unimportant ones, and enhancing the comprehension of event relationships is made easy. With ASM, you'll be able to navigate through long record length acquisitions effortlessly and quickly locate the event you have been trying to find. Advanced searches can be defined individually or using the scope's trigger settings as the definition for the search. Even Visual Trigger areas can be used as part of the ASM criteria.



Advanced Search and Mark - Highlights important events and provides convenient previous and next buttons and mouse clicks to navigate between events of interest effortlessly

Probing and remote-head coaxial input

Often the biggest challenge in debugging a system is getting access to the required signals. Tektronix offers a wide array of probing solutions, including the P7700, P7600, and P7500 TriMode™ probing system with bandwidths that are perfectly matched to the DPO7000SX Series. The P7700, P7600, and P7500 TriMode probes allow you to switch among differential, single ended, and common-mode measurements without moving the probe from its connection points. The P7600 Series combines low noise, 33 GHz bandwidth and the convenience of Trimode probing. The P7500 Series offers probes with performance from 4 GHz to 25 GHz and offers several low-cost solder tips with quick connection features that allow moving the probe to various solder points fast and easy.



The low-cost solder tips available for the P7500 TriMode probes allow quick connection so moving the probe to various solder points is fast and easy.

P7700 Series TriMode Probes

The P7700 Series TriMode probes provide the highest probe fidelity available for real-time oscilloscopes. In addition, with connectivity innovations such as solder down tips with the probe's input buffer mounted only a few millimeters from the end of the tip, the P7700 Series probes provide unmatched usability for connecting to today's most challenging electronic designs.



P77STFLXA solder down, flex circuit accessory with an active buffer amplifier on its tip provides up to 20 GHz bandwidth.

DPO70E Series Optical Probes

The DPO70E Series Optical probes can be used as an Optical Reference Receiver for high speed serial data signals (using selectable Bessel-Thomson ORR filters), or can be used as a conventional O/E converter for general wide-bandwidth optical signal acquisition. The DPO70E Series is compatible with DPO/MSO70000 C/DX/SX models. Connected to TekConnect channels for up to 33 GHz bandwidth. Connected to ATI channels, the DPO70E1 provides up to 42 GHz electrical response; the DPO70E2 provides up to 59 GHz electrical bandwidth response.



DPO70E1 33 GHz Optical Probe

Signal acquisition

ATI input

The DPO77002SX 70 GHz ATI input channel uses industry-standard 1.85 mm coaxial connection system specified to 67 GHz, with typical performance to 70 GHz. The instrument includes a calibration-grade 1.85 mm female-female adapter installed in the ATI input connector (male) to provide mechanical protection and gender selection. Instruments also include a static protection wrist strap, torque wrench and a set of backing wrenches to facilitate proper care and installation of signal path elements, ensuring optimal measurement performance. The 1.85 mm connection system is compatible with 2.4 mm (50 GHz) elements.

TekConnect® inputs

DPO70000SX models include the TekConnect signal interconnect system, offering unparalleled versatility with a wide array of accessory signal access and conditioning solutions. The TCA292D TekConnect adapter provides 2.92 mm connection, 50 Ω coaxial environment to 33 GHz.

High performance Auxiliary Trigger input

DPO70000SX includes an Auxiliary Trigger input (TekConnect) suitable for high performance Edge triggering without consuming an acquisition channel. Aux trigger bandwidth is >10 GHz on the DPO70000SX Series with <1.5 ps_{RMS} jitter.

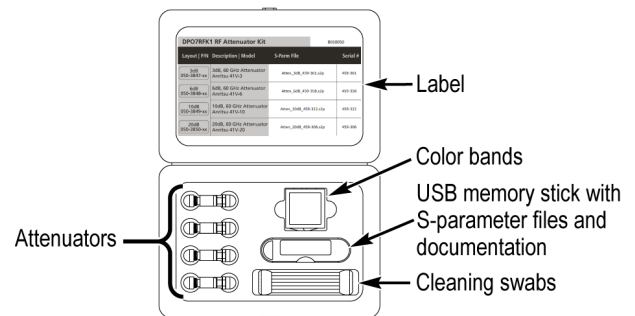
Channel timing deskew

All DPO70000SX models include differential fast-edge outputs matched to <1.6 ps on the front panel that provide a convenient source for aligning channel timing in a coaxial environment. Instruments include accessories to accomplish channel-to-channel timing deskew using the built-in source. Additional accessories can be purchased separately to accomplish even finer time alignment or deskew in a probe-based environment

DPO7RF Signal Path Solutions

The DPO7RF Signal Path Solutions kits provide you with preconfigured kits of components you can use to optimize measurement performance in your ultra-high bandwidth applications. Kits include attenuators, adapters, DC Blocks, power divider, cleaning swabs, color marking bands, S-parameters and documentation.

- Kits and cables include S-parameter files and documentation on a USB memory stick
- Kits include signal path marking accessories
- Kits include cleaning swabs for proper maintenance of sensitive RF components



DPO7RFK1-1.85 mm characterized attenuator kit.

Rack environment

The DPO70000SX rack mount is a tray directly attached to the instrument. The tray occupies 1U rack height in addition to the 3U instrument and preserves a cooling channel for the unit. The rack mount also provides heavy-duty carry handles for transporting the instrument outside the rack environment.

The rack-mounting kit allows units to be mounted upright or inverted to minimize input cable length, just as when stacking on a bench.

The DPO70000SX rack-mount tray can also house a front-mounted Solid State Drive (SSD) for easy access to instrument mass storage in a rack environment.



Specifications

All specifications are guaranteed unless noted otherwise. All specifications apply to all models unless noted otherwise.

Model overview

	DPO77002SX/DPS77004SX		DPO75902SX/DPS75904SX		DPO75002SX/DPS75004SX	
	ATI channel	TekConnect channels	ATI channel	TekConnect channels	ATI channel	TekConnect channels
Analog channels/bandwidth	DPO77002SX 1 ch/67 GHz 1 ch/70 GHz (typical) DPS77004SX 2 ch/67 GHz 2 ch/70 GHz (typical)	DPO77002SX 2 ch/33 GHz DPS77004SX 4 ch/33 GHz	DPO75902SX 1 ch/59 GHz DPS75904SX 2 ch/59 GHz	DPO75902SX 2 ch/33 GHz DPS75904SX 4 ch/33 GHz	DPO75002SX 1 ch/50 GHz DPS75004SX 2 ch/50 GHz	DPO75002SX 2 ch/33 GHz DPS75004SX 4 ch/33 GHz
Sample rate per channel	200 GS/s	100 GS/s	200 GS/s	100 GS/s	200 GS/s	100 GS/s
Rise time (typical)	10% to 90%: 5.6 ps 20% to 80%: 4.3 ps	10% to 90%: 13 ps 20% to 80%: 9 ps	10% to 90%: 6.8 ps 20% to 80%: 5.2 ps	10% to 90%: 13 ps 20% to 80%: 9 ps	10% to 90%: 7.8 ps 20% to 80%: 6 ps	10% to 90%: 13 ps 20% to 80%: 9 ps
Vertical Noise (% of full scale), BWE on, max sample rate (typical)	0.83% of full scale 0.75% of full scale @ 0 V offset (300 mV _{FS})	0.71% of full scale 0.56% of full scale @ 0 V offset (500 mV _{FS})	0.83% of full scale 0.75% of full scale @ 0 V offset (300 mV _{FS})	0.71% of full scale 0.56% of full scale @ 0 V offset (500 mV _{FS})	0.83% of full scale 0.75% of full scale @ 0 V offset (300 mV _{FS})	0.71% of full scale 0.56% of full scale @ 0 V offset (500 mV _{FS})
Record length, points (each channel, standard)	62.5 M	62.5 M	62.5 M	62.5 M	62.5 M	62.5 M
Record length (each channel, Opt. 10XL)	125 M	125 M	125 M	125 M	125 M	125 M
Record length (each channel, Opt. 20XL)	250 M	250 M	250 M	250 M	250 M	250 M
Record length (each channel, Opt. 50XL)	1 G	1 G	1 G	1 G	1 G	1 G
Timing resolution	5 ps (200 GS/s)	10 ps (100 GS/s)	5 ps (200 GS/s)	10 ps (100 GS/s)	5 ps (200 GS/s)	10 ps (100 GS/s)
Duration at highest sample rate (Standard)	313 μs	625 μs	313 μs	625 μs	313 μs	625 μs
Duration at highest sample rate (Opt. 10XL)	625 μs	1.25 ms	625 μs	1.25 ms	625 μs	1.25 ms
Duration at highest sample rate (Opt. 20XL)	1.25 ms	2.5 ms	1.25 ms	2.5 ms	1.25 ms	2.5 ms
Duration at highest sample rate (Opt. 50XL)	5.0 ms	10 ms	5.0 ms	10 ms	5.0 ms	10 ms

	DPO73304SX/DPS73308SX	DPO72304SX
	TekConnect channels	TekConnect channels
Analog channels/bandwidth	DPO73304SX 2 ch/33GHz, 4 ch/23GHz DPS73308SX 4 ch/33GHz, 8 ch ⁴ /23GHz	DPO72304SX 4 ch/23GHz
Sample rate per channel	DPO73304SX 2 ch 100 GS/s, 4 ch 50 GS/s DPS73308SX 4 ch 100 GS/s, 8 ch ⁴ 50 GS/s	2 ch 100 GS/s, 4 ch 50 GS/s
Rise time (typical)	10% to 90%: 13 ps 20% to 80%: 9 ps	10% to 90%: 17 ps 20% to 80%: 13 ps

⁴ Maximum of 4 channels displayed on-screen. Additional channels data available through program interface.

Model overview

	DPO73304SX/DPS73308SX	DPO72304SX
	TekConnect channels	TekConnect channels
Vertical Noise (% of full scale), BWE on, max sample rate (typical)	0.71% of full scale	0.71% of full scale
	0.56% of full scale @ 0V offset (500 mV _{FS})	0.56% of full scale @ 0 V offset (500 mV _{FS})
Record length, points (each channel, standard)	62.5 M	62.5 M
Record length (each channel, Opt. 10XL)	125 M	125 M
Record length (each channel, Opt. 20XL)	250 M	250 M
Record length (each channel, Opt. 50XL)	DPO73304SX 1 G on 2 ch, 500 M on 4 ch DPS73308SX 1 G on 2 ch each unit, 500 M on 4 ch each unit	1 G on 2 ch, 500 M on 4 ch
Timing resolution	10 ps (100 GS/s)	10 ps (100 GS/s)
Duration at highest sample rate (Standard)	625 μs	625 μs
Duration at highest sample rate (Opt. 10XL)	1.25 ms	1.25 ms
Duration at highest sample rate (Opt. 20XL)	2.5 ms	2.5 ms
Duration at highest sample rate (Opt. 50XL)	10 ms	10 ms

Vertical system - analog channels

Input coupling

TekConnect channels: Two modes: DC, 50 ohms to a programmable termination voltage; Ground.
The termination can be connected to a DC voltage:
≤ 1.2 V_{FS} settings: -3.5 V to 3.5 V,
> 1.2 V_{FS} settings: 0.0 V

ATI channel: DC, 50 Ω.

Input resistance

≤1.2 V_{FS} settings 50 Ω ±3% at 18 to 28 °C (64 to 82 °F)
50 Ω ±4% over 5 to 45 °C (45 to 113 °F)

>1.2 V_{FS} settings 50 Ω ±4.4% over 5 to 45 °C (45 to 113 °F)

Sensitivity range

TekConnect channels 62.5 mV_{FS} to 6 V_{FS}
ATI channel 100 mV_{FS} to 300 mV_{FS}.

Vertical system - analog channels

Maximum input voltage

TekConnect channels:	$\leq 1.2 V_{FS}$ settings: $\pm 1.5 V$ relative to the termination bias (30 mA maximum) $\pm 5 V$ absolute maximum input $> 1.2 V_{FS}$ settings: $\pm 8 V$. Limited by maximum V_{term} current and the attenuator power rating at maximum temperature.
ATI channel:	$\pm 0.75 V_{pk}$
Aux channel:	$\pm 5.0 V_{pk}$

Input termination voltage (V_{Term}) range, TekConnect channels

$\leq 1.2 V_{FS}$ settings:	-3.5 V to +3.5 V
$> 1.2 V_{FS}$ settings:	0 V

Frequency response tolerance

All modes, BWE on, 18 °C to 28 °C (typical)

TekConnect channel:	Step settings TekConnect channels: 77.5 mV _{FS} , 151 mV _{FS} , 302 mV _{FS} , 605 mV _{FS} , 1210 mV _{FS} , 1620 mV _{FS} , 3240 mV _{FS} ± 0.5 dB from DC to 50% of nominal BW ± 1.5 dB from 50% to 80% of nominal BW All other gain settings: ± 1.0 dB from DC to 50% of nominal BW ± 2.0 dB from 50% to 80% of nominal BW
ATI channel:	All volts/div settings ± 0.5 dB from DC to 20 GHz ± 0.75 dB from >20 GHz to 30 GHz ± 1.25 dB from >30 GHz to 68.5 GHz ± 2 dB from >68.5 GHz to 69.5 GHz $+2 / -3$ dB at 70 GHz

Bandwidth limit	Depending on instrument model: 70 GHz to 1 GHz in 1 GHz steps, or 500 MHz; 5 GHz steps above 35 GHz Hardware-only bandwidth settings at 33 GHz available on non-ATI channels. No hardware-only settings available on ATI channel.
------------------------	--

Vertical resolution	8 bits, (11 bits with averaging)
----------------------------	----------------------------------

DC gain accuracy	$\pm 2\%$
-------------------------	-----------

Effective number of bits (typical).
Average value from DC to full bandwidth of model.

70 GHz ATI Channel	4.6 bits at 250 mV FS, 200GS/s
59 GHz ATI Channel	4.8 bits at 250 mV FS, 200GS/s
50 GHz ATI Channel	5.0 bits at 250 mV FS, 200GS/s
33 GHz TekConnect Channels	5.0 bits at 500 mV FS, 100GS/s
23 GHz TekConnect Channels	5.4 bits at 500 mV FS, 100GS/s

Vertical system - analog channels

Offset range

TekConnect channels

Full Scale voltage range	Offset range
62.5 mV _{FS} – 1.2 V _{FS}	±3.4 V
>1.2 V _{FS} – 6 V _{FS}	±6 V

ATI channel

Full Scale voltage range	Offset range
100 mV _{FS} – 300 mV _{FS}	±300 mV - (10 div × Volts/div)

Offset accuracy

Full scale voltage range	Offset accuracy
62.5 mV _{FS} to 1.2 V _{FS} (TekConnect channels)	±(0.4% net offset + 0.2% net offset – Vterm setting + 2.5 mV + 1% FS)
>1.2 V _{FS} to 6 V _{FS} (TekConnect channels)	±(0.6% net offset + 13.4 mV + 1% FS)
100 mV _{FS} to 300 mV _{FS} (ATI channel)	±(0.35% net offset + 2 mV + 1% FS)

Position range

± 5 divisions

Channel-to-channel crosstalk (channel isolation), typical

Input frequency range (up to the rated bandwidth). Assumes two channels with the same scale and bandwidth settings. The limits apply up to the bandwidth of the particular instrument.

ATI models		
Specified channels	Instrument frequency range	Isolation
ATI channels (isolation between any two [or more] ATI channels in separate units), requires UltraSync	DC to 70 GHz	70 dB
TekConnect channels in an ATI unit (isolation between channels 1 and 3)	DC to 33 GHz	60 dB
TekConnect channels to ATI channel (isolation between channels 1 and 3 to channel 2)	DC to 4 GHz	55 dB
	>4 GHz to 10 GHz	45 dB
	>10 GHz to 20 GHz	35 dB
	>20 GHz to 30 GHz	30 dB
	>30 GHz to 33 GHz	27 dB
ATI channel to TekConnect (non-ATI) channels (isolation between channel 2 and channels 1 or 3)	DC to 3 GHz	55 dB
	>3 GHz to 12 GHz	40 dB
	>12 GHz to 33 GHz	30 dB
	>33 to 70 GHz	60 dB

TekConnect models (non-ATI)		
Specified channels	Instrument frequency range	Isolation
Isolation between channels 1 or 2 and channels 3 or 4	DC to 33 GHz	60 dB
Isolation between channels 1 and 2, or channels 3 and 4	DC to 2 GHz	60 dB
	>2 to 10 GHz	42 dB
	>10 to 20 GHz	35 dB
	>20 to 33 GHz	30 dB

Vertical system - analog channels

Displayed Average Noise Level (DANL) (typical) 6.25 mV/div (10 mV/div for ATI channel)
 500 kHz span, 1 kHz RBW
 Peak detector, averaged trace, input terminated

DC-500 MHz	≤ -145 dBm/Hz	29 dB NF
500 MHz - 20 GHz	≤ -155 dBm/Hz	19 dB NF
20 GHz - 70 GHz	≤ -150 dBm/Hz	24 dB NF

Signal to noise dynamic range (typical)

TekConnect channel	3 dBm input @ 1 GHz, 100 mV/div CF 1 GHz, 50 MHz span, 1 kHz RBW, +20 MHz from center	-102 dB
ATI channel	-7.5 dBm input @ 65 GHz, 30 mV/div CF 65 GHz, 50 MHz span, 1 kHz RBW, +20 MHz from center	-95 dB

Phase noise (typical)

30 mV/div, input signal 90% full scale

	10 kHz	100 kHz	1 MHz	10 MHz
1 GHz	-113 dBc/Hz	-120 dBc/Hz	-133 dBc/Hz	-139 dBc/Hz
12.5 GHz	-95 dBc/Hz	-98 dBc/Hz	-127 dBc/Hz	-139 dBc/Hz
40 GHz	-86 dBc/Hz	-89 dBc/Hz	-110 dBc/Hz	-132 dBc/Hz
60 GHz	-82 dBc/Hz	-87 dBc/Hz	-110 dBc/Hz	-125 dBc/Hz

2nd/3rd harmonic distortion

6.25 mV/div (10 mV/div for ATI channel)
 Input signal -26 dBm (-22 dBm for ATI channel)

	Fundamental	2 nd	3 rd
TekConnect channel			
1 GHz		≤ -60 dBc	≤ -55 dBc
500 MHz - 10 GHz		≤ -55 dBc	≤ -50 dBc
10 GHz - 16.5 GHz		≤ -45 dBc	≤ -50 dBc
ATI channel			
1 GHz		≤ -60 dBc	≤ -50 dBc
500 MHz - 10 GHz		≤ -60 dBc	≤ -45 dBc
10 GHz - 25 GHz		≤ -50 dBc	≤ -50 dBc
25 GHz - 35 GHz		≤ -40 dBc	≤ -50 dBc

2 Tone 3rd order intermodulation intercept TOI (typical)

TekConnect channel	200 mV/div, 3 dBm input/tone 2.598 GHz and 2.602 GHz 20 MHz span, 100 kHz RBW	+30 dBm
ATI channel	30 mV/div, -15 dBm input/tone 64.998 GHz and 65.002 GHz 20 MHz span 100 kHz RBW	+10 dBm

Vertical system - analog channels

2 Tone 3rd order intermodulation distortion (typical) 6.25 mV/div (10 mV/div for ATI CH)
 -34 dBm input/tone (-29 dBm input/tone for ATI channel)
 10 MHz separation, 50 MHz span, 100 kHz RBW

TekConnect 10 MHz - 33 GHz	≤ -45 dBc
ATI channel 10 MHz - 65 GHz	≤ -40 dBc

SFDR (typical)

TekConnect channel CF 2.5 GHz, span 5 GHz, 100 kHz RBW, 50 mV/div Input -8 dBm @ 1 GHz	≤ -65 dBc
ATI channel CF 65 GHz, span 6 GHz, 100 kHz RBW, 30 mV/div Input -12 dBm @ any frequency from 62 GHz - 68 GHz	≤ -55 dBc

Other spurious responses (typical) 6.25 mV/div (10 mV/div for ATI channel)
 Input signal -26 dBm (-22 dBm for ATI channel)
 After SPC, EENOB enabled

Interleave image (all channels)	Spur freq. = N(12.5 GHz) +-Fin, N from 1 to 5	≤ -40dBc
--	---	----------

ATI channel image	Spur freq. = 37.5 GHz + Fin for Fin DC-37.5 GHz 37.5 GHz - Fin for Fin 37.5 GHz to 70 GHz	≤ -30dBc
--------------------------	--	----------

Residual responses With input terminated
 6.25 mV/div (10 mV/div for ATI channel)
 After SPC, EENOB enabled

TekConnect channel Exceptions at 12.5 GHz and 25 GHz	≤ -75 dBm ≤ -60 dBm
ATI channel Exceptions at 12.5 GHz, 25 GHz, 37.5 GHz, and 50 GHz	≤ -75 dBm ≤ -60 dBm

Input VSWR (typical)

TekConnect channel ≤ 1.2 Vfs settings	DC - 17 GHz 17 GH - 20 GHz 20 GHz - 33 GHz	1.4:1 1.6:1 2.0:1
--	--	-------------------------

TekConnect channel >1.2 Vfs settings	DC - 17 GHz 17 GHz - 33 GHz	1.4:1 2.0:1
--	--------------------------------	----------------

ATI channel	DC - 20 GHz 20 GHz - 33 GHz 33 GHz - 70 GHz	1.5:1 1.8:1 2.6:1
--------------------	---	-------------------------

Horizontal system

Time base accuracy	$\pm 0.8 \times 10^{-6}$ (within 1 st year), $\pm 0.3 \times 10^{-6}$ aging/year after first year when operated within 23°C $\pm 5^\circ\text{C}$ after 30 minute warm-up. Typical: $\pm 0.1 \times 10^{-6}$ initial accuracy after adjustment.
Time base delay time range	-5.0 ks to 1.0 ks
Sample Clock Jitter (typical)	
ATI channel	<10 μs Duration: <65 fs_{RMS}
TekConnect channel	<10 μs Duration: <100 fs_{RMS}
Trigger jitter (typical)	10 fs using enhanced trigger placement.
Time/Div settings	
ATI channel (only sample rate is 200 GS/s)	Max RT setting: 500 $\mu\text{s}/\text{div}$ (with 1G RL, 50XL option) Min RT setting: 25 ps/div Max IT setting: 250 $\mu\text{s}/\text{div}$ (with 1G RL, 50XL option) Min IT setting: 500 fs/div
TekConnect channels⁵ (at max sample rate of 100 GS/s)	Max RT setting: 1 ms/div (with 1G RL, 50XL option) Min RT setting: 50 ps/div Max IT setting: 10 $\mu\text{s}/\text{div}$ (with 1G RL, 50XL option) Min IT setting: 500 fs/div
Delay between channels, BWE (typical)	≤ 500 fs between any two channels within the same box at any gain setting at 25 °C $\pm 5^\circ\text{C}$ prior to any user adjustment. Manual adjustment available with 10 fs minimum resolution. Derate linearly to ≤ 1.5 ps at 5 °C and 45 °C.
Channel skew stability, UltraSync (typical)	≤ 250 fs_{RMS} between any two channels between instruments at any gain setting at 25 °C $\pm 5^\circ\text{C}$. Derate linearly to ≤ 3 ps at 5 °C and 45 °C.
Channel-to-Channel deskew range	± 75 ns

Acquisition system

Acquisition modes

Sample	Acquires and displays sampled values
Average	From 2 to 10,000 waveforms can be included in an average waveform
Envelope	From 1 to 2×10^9 waveforms included in min-max envelope
Hi-Res	Real-time boxcar averaging reduces random noise and increases resolution
Peak detect	Capture and display narrow glitches at all real-time sampling rates. Glitch widths: 1 ns at ≤ 125 MS/s; 1/sample rate at ≥ 250 MS/s
FastAcq® (TekConnect channels only)	FastAcq® optimizes the instrument for analysis of dynamic signals and capture of infrequent events, capturing >300,000 waveforms per second on all TekConnect channels simultaneously, standalone configuration only
FastFrame™	Acquisition memory divided into segments; maximum trigger rate >310,000 waveforms per second. Time of arrival recorded with each event. Frame finder tool helps to visually identify transients. Available for both ATI and TekConnect channels, for all system configurations including stand-alone and multi-unit stacks using UltraSync.
Roll mode	Scrolls sequential waveform points across the display in a right-to-left rolling motion. Works at sample rates up to 10 MS/s with a maximum record length of 40 MS. TekConnect channels only, standalone configuration only
Waveform database	Accumulates waveform data providing a three-dimensional array of amplitude, time, and counts. TekConnect channels only, standalone configuration only

⁵ Sample rate on TekConnect channels can be varied down to 3.125 samples/second, resulting in a max RT setting of 6.55 Ms/div, with a record length of 205 M (requires 250 M or higher RL, 20XL option)

Pinpoint® Trigger system

Trigger sensitivity (typical)

Internal DC coupled

A-Event trigger, B-Event trigger	$\leq 5\%FS$ from DC to 50 MHz $\leq 7.5\%FS$ at 5 GHz $\leq 10\%FS$ at 10 GHz $\leq 15\%FS$ at 15 GHz $\leq 35\%FS$ at 20 GHz $\leq 50\%FS$ at 25 GHz
----------------------------------	---

Aux input 50 Ω (external trigger)

Auxiliary input	100 mV _{pp} from DC to 1 GHz 175 mV _{pp} at 4 GHz 225 mV _{pp} at 8 GHz 325 mV _{pp} at 10 GHz 800 mV _{pp} at 12 GHz
-----------------	---

Edge trigger sensitivity, non-DC-coupled modes (typical)

All sources, positive or negative edge, for vertical scale settings ≥ 10 mV/div and ≤ 1 V/div

Trigger Coupling	Sensitivity
NOISE REJ	15%FS from DC to 50 MHz 22.5% at 5 GHz 30%FS at 10 GHz 45%FS at 15 GHz 100%FS at 20 GHz
AC	Same as DC-coupled limits for frequencies > 100 Hz, attenuates signals < 100 Hz
HF REJ	Same as DC-coupled limits for frequencies < 20 kHz, attenuates signals > 20 kHz
LF REJ	Same as DC-coupled limits for frequencies > 200 kHz, attenuates signals < 200 kHz
RF	Minimum hysteresis / High sensitivity A TRIG TekConnect 2.5% FS from DC to 50 MHz 2.5% FS at 5 GHz 2.5% FS at 10 GHz 5% FS at 15 GHz 7.5% FS at 20 GHz 12.5% FS at 25 GHz B TRIG TekConnect 2.5% FS from DC to 50 MHz 2.5% FS at 5 GHz 2.5% FS at 10 GHz 5% FS at 15 GHz 7.5% FS at 20 GHz 20% FS at 25 GHz A TRIG ATI 2.5% FS from DC to 50 MHz 2.5% FS at 5 GHz 2.5% FS at 10 GHz 5% FS at 15 GHz 10% FS at 20 GHz 22.5% FS at 25 GHz B TRIG ATI 2.5% FS from DC to 50 MHz 2.5% FS at 5 GHz 2.5% FS at 10 GHz 5% FS at 15 GHz 10% FS at 20 GHz 22.5% FS at 25 GHz

Pinpoint® Trigger system

A-Event and delayed B-Event trigger types

Standalone instrument	DPO73304SX DPO72304SX	DPO77002SX DPO75902SX DPO75002SX	
Trigger type	TekConnect channel	ATI channel	TekConnect channel
Edge	X	X	X
Glitch	X	X	X
Width	X	X	X
Runt	X	X	X
Serial (8b10b)	X	X	X
Window	X	X	X
Timeout	X	X	X
Period/Frequency	X	X	X
Envelope	X	X	X
Transition	X	X	X
Logic Pattern	X		X
Setup/Hold	X		X
Logic state	X		

Multi-unit configuration	DPO73304SX DPO72304SX	DPO77002SX DPO75902SX DPO75002SX	
Trigger type	TekConnect channel	ATI channel	TekConnect channel
Edge	X	X	X
Glitch	X	X	X
Width	X	X	X

Main trigger modes Auto, Normal, and Single

Trigger sequences Main, Delayed by Time, Delayed by Events, Reset by Time, Reset by State, Reset by Transition. All sequences can include a separate horizontal delay after the trigger event to position the acquisition window in time

Trigger coupling DC, AC (attenuates <100 Hz)
 HF Rej (attenuates >20 kHz)
 LF Rej (attenuates <200 kHz)
 Noise Reject (reduces sensitivity)
 RF coupling (increases trigger sensitivity and bandwidth at the highest operating frequencies)

Variable A-Event trigger holdoff range 250 ns to 12 s + random holdoff

Trigger level or threshold range

Trigger Source	Range
Ch1, 2, 3, or 4	Full scale
Auxiliary input	±3.65 V
Line	0 V, Not settable

Pinpoint® Trigger system

Enhanced triggering Enhanced triggering corrects the difference in timing between the trigger path and the acquired data path (supports all Pinpoint trigger types on both A- and B-Events except pattern trigger); Default On (user-selectable); Not available in FastAcq mode.

Line trigger Trigger on power line signal. Level fixed at 0 V.

Serial pattern trigger All 70000SX models. Requires Option ST14G

Visual Trigger Requires Option VET

Max number of areas 8

Area shapes Rectangle, Triangle, Trapezoid, Hexagon, user defined shapes (can have >40 vertices)

Compatibility Visual Trigger qualification is compatible with all trigger types and all trigger sequences

Trigger types

Trigger type	Description
Bus Trigger	Trigger on 8b10b buses, up to 160 bits
Edge	Positive or negative slope on any channel or front-panel auxiliary input. Coupling includes DC, AC, noise reject, HF reject, LF reject, and RF coupling.
Frequency/Period	Trigger on event that crosses threshold twice with same slope within or outside of selectable time limits. Slope may be positive, negative or either.
Glitch	Trigger on or reject glitches of positive, negative, or either polarity. Minimum glitch width is 40 ps (typical) with rearm time of 50 ps (<5 ns interval), 75 ps above 5 ns.
Pattern	Trigger when pattern goes false or stays true for specified period of time. Pattern (AND, OR, NAND, NOR) specified for four input channels.
Runt	Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again. Event can be time- or logic-qualified. Minimum runt width is 40 ps (typical) with rearm time of 50 ps
Serial Trigger (8b10b)	Trigger on 8b10b encoded data, up to 160 bits
Setup/Hold	Trigger on violations of both setup time and hold time between clock and data present on any two input channels.
State	Any logical pattern of channels (1, 2, 3) clocked by edge on channel 4. Trigger on rising or falling clock edge.
Timeout	Trigger on an event which remains high, low, or either, for a specified time period. Selectable from 300 ps.
Transition	Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either.
Width	Trigger on width of positive or negative pulse either within or out of selectable time limits (down to 40 ps).
Window	Trigger on an event that enters or exits a window defined by two user-adjustable thresholds. Event can be time or logic qualified.
Visual Trigger	Trigger when the Visual Trigger expression is satisfied.
Envelope	Qualification applied to Edge, Glitch, Width or Runt trigger such that trigger type is performed on the detected envelope of a modulated carrier. Carrier frequency 250 MHz to 15 GHz. Minimum burst width <20 ns, maximum gap between bursts <20 ns.

Pinpoint® Trigger system

Trigger modes

Trigger mode	Description
Trigger Delay by Events	1 to 2 billion events.
Trigger Delay by Time	3.2 ns to 3 million seconds.
B-Event Scan	B-Event Scan is an A to B trigger sequence that will trigger and capture burst event data of interest as defined in the B-Event Scan setup menu. Captured bits can be scanned in a sequential or randomized fashion, and alternatively the trigger can toggle between two successive B trigger events. Eye diagrams can be constructed with burst data acquired as a result of scanning B-Event.
Arm A, Trig B	Arm on A, Trig on B allows for a single A arming event followed by one or more B trigger events. When combined with FastFrame, allows for very tight acquisition timing control.

Waveform analysis

Search and Mark Events

Search for edges, glitches, or pulses of specified width. Any events found matching the search criteria are marked and placed in the Event table. The search can use positive/negative slopes or both on any channels.

When an event of interest is found, other similar events can be found using "Mark All Trigger Events in Record" in the Pinpoint trigger control windows.

The Event table summarizes all found events. All events are time stamped in reference to trigger position. Users can choose to stop acquisitions when an event is found.

Waveform measurements

Automatic measurements

54, of which 8 can be displayed on-screen at any one time; measurement statistics, user-definable reference levels, measurement within gates isolating the specific occurrence within an acquisition to measure

The DPOJET Jitter and Eye Analysis application offers additional automated and advanced measurements such as jitter.

Amplitude related

Amplitude, High, Low, Maximum, Minimum, Peak-to-Peak, Mean, Cycle Mean, RMS, Cycle RMS, Positive Overshoot, Negative Overshoot

Time related

Rise Time, Fall Time, Positive Width, Negative Width, Positive Duty Cycle, Negative Duty Cycle, Period, Frequency, Delay

Combination

Area, Cycle Area, Phase, Burst Width

Histogram related

Waveform Count, Hits in Box, Peak Hits, Median, Maximum, Minimum, Peak-to-Peak, Mean (μ), Standard Deviation (σ), $\mu + 1\sigma$, $\mu + 2\sigma$, $\mu + 3\sigma$

Waveform processing/math

Algebraic expressions

Define extensive algebraic expressions including Waveforms, Scalars, User-adjustable Variables, and Results of Parametric Measurements e.g. $(\text{Integral}(\text{CH1} - \text{Mean}(\text{CH1})) \times 1.414 \times \text{VAR1})$

Arithmetic

Add, Subtract, Multiply, Divide Waveforms and Scalars

Filtering function

User-definable filters. Users specify a file containing the coefficients of the filter. Several example filter files are provided

Frequency domain functions

Spectral Magnitude and Phase, Real and Imaginary Spectra

Mask function

Generates a Waveform Database pixel map from a sample waveform. Sample count can be defined

Math functions

Average, Invert, Integrate, Differentiate, Square Root, Exponential, Log 10, Log e, Abs, Ceiling, Floor, Min, Max, Sin, Cos, Tan, ASin, ACos, ATan, Sinh, Cosh, Tanh

Relational

Boolean result of comparison $>$, $<$, \geq , \leq , $==$, $!=$

Vertical units

Magnitude: Linear, dB, dBm Phase: Degrees, radians, group delay IRE and mV units

Window functions

Rectangular, Hamming, Hanning, Kaiser-Bessel, Blackman-Harris, Gaussian, Flattop2, Tek Exponential

Customized Functions using Math Plug-in Interface

An interface is provided to allow users to create their own custom math functions in MATLAB or Visual Studio

Display system

Color palettes	Normal, Green, Gray, Temperature, Spectral, and User-defined
Format	YT, XY, XYZ
Display resolution	1024 horizontal × 768 vertical pixels (XGA)
Display type	6.5 in. liquid-crystal active-matrix color display with capacitive touch screen
Horizontal divisions	10
Vertical divisions	10
Waveform styles	Vectors, Dots, Variable Persistence, Infinite Persistence

Computer system and peripherals

Operating system	Microsoft Windows 10 Enterprise IoT Edition
CPU	INTEL CORE I7-4790S, 3.2 GHz, QUAD CORE
System memory	32 GB
Solid state drive	Removable, ≥900 GB capacity
Mouse	Optical wheel mouse, USB interface
Keyboard	USB interface

Input-output ports

Auxiliary trigger input characteristics and range	50 Ω, ±5 V (DC plus peak AC)
Auxiliary output logic polarity and functionality	Default output is A trigger low true (a negative edge when the A trigger event occurs). You can also program the output to A trigger high true, and B trigger low or high true.
Fast Edge output step amplitude and offset	1200 mV differential into a 100 Ω load with a -300 mV common mode.
External reference input frequency	10 MHz, 100 MHz, 12.5 GHz The instrument scans for either 10 MHz or 100 MHz. 12.5 GHz supported on separate SMA input.
12.5 GHz Clock In	1.3 V _{p-p} (6 dBm)
B, C, D 12.5 GHz Clock Out (UltraSync)	1.3 V _{p-p} (6 dBm)
Internal reference output voltage (typical)	
10 MHz Vout pk-pk	> 800 mV peak-peak into 50 Ω > 1.6 V peak-peak into 1 MΩ (internally AC coupled).

Input-output ports

Input and output ports

DVI-D Video port	A female Digital Visual Interface (DVI-D) compatible port
VGA port	A female Video Graphics Array (VGA) compatible port
DisplayPort	Two connectors (primary, secondary) provide digital display interfaces
PCIe	PCIe ports to configure multi-instrument systems
Trigger	UltraSync trigger bus
Keyboard and Mouse ports	PS-2 compatible, instrument must be powered down to make connection
LAN ports	Two RJ-45 connectors (LAN1, LAN2), support 10BASE-T, 100BASE-TX, and Gigabit Ethernet
External audio ports	External audio jacks for microphone input and line output
USB ports	Four front panel USB 2.0 connectors Four rear panel USB 3.0/USB 2.0 connectors One rear panel USB device connector

Data storage specifications

Nonvolatile memory retention time (typical) >20 years

Solid state drive Waveforms and setups are stored on the solid state drive.
Solid state drive is a ≥ 900 GB solid state drive (removable).

Power source

Power consumption <980 W, single instrument, maximum
 ≤ 780 W, single unit (typical)

Source voltage and frequency 100 V to 240 V_{RMS}, 50/60 Hz
115 V $\pm 10\%$, 400 Hz
CAT II

Mechanical specifications

Dimensions

DPO70000SX models	157 mm (6.0 in) height 452 mm (17.8 in) width 553 mm (21.8 in) depth
DPO70000SX models, Rackmount configuration	177 mm (7.0 in) height 440 mm (19.75 in) width 523 mm (20.6 in) depth (from rack mounting ear to back of instrument)

Weight

DPO70000SX models 19 kg (42 lbs) oscilloscope only

Mechanical specifications

Cooling

Required clearances

Fan-forced air circulation with no air filter	
Top	0 mm (0 in)
Bottom	6.35 mm (0.25 in) minimum or 0 mm (0 in) when standing on feet, flip stands down
Left side	76 mm (3 in)
Right side	76 mm (3 in)
Rear	0 mm (0 in) on rear feet

Environmental specifications

Temperature

Operating	+5 °C to +45 °C
Nonoperating	-20 °C to +60 °C

Humidity

Operating	8% to 80% relative humidity at up to +32 °C (+90 °F)
	5% to 45% relative humidity above +32 °C (+90 °F) up to +45 °C (+113 °F), noncondensing, and is limited by a maximum wet-bulb temperature of +29.4 °C (+85 °F) (derates relative humidity to 32% at +45 °C (+113 °F))
Nonoperating	5% to 95% relative humidity at up to +30 °C (+86 °F),
	5% to 45% relative humidity above +30 °C (+86 °F), up to +60 °C (+140 °F), noncondensing, and is limited by a maximum wet-bulb temperature of +29.4 °C (+85 °F) (derates relative humidity to 11% at +60 °C (+140 °F))

Altitude

Operating	Up to 3,000 meters
Nonoperating	Up to 12,000 meters

Regulatory

Electromagnetic compatibility	2004/108/EC; EN 61326-2-1
Certifications	UL 61010-1, CSA 61010-1-04, LVD 2006/95/EC, EN61010-1, IEC 61010-1

Ordering information

Models

DPO77002SX	70 GHz ATI Performance Oscilloscope
DPO75902SX	59 GHz ATI Performance Oscilloscope
DPO75002SX	50 GHz ATI Performance Oscilloscope
DPO73304SX	33 GHz Digital Phosphor Oscilloscope
DPO72304SX	23 GHz Digital Phosphor Oscilloscope

Systems

The following DPS systems provide single-nomenclature ordering convenience for 2 instruments and a 1 meter UltraSync cable. The same options may be applied to these systems as with base models and the option will be included on both instruments. Both component instruments will have the same options associated with the system nomenclature when operating standalone.

DPS77004SX	70 GHz ATI Performance Oscilloscope System: 2 x 70 GHz, 200 GS/s or 4 x 33 GHz, 100 GS/s
DPS75904SX	59 GHz ATI Performance Oscilloscope System: 2 x 59 GHz, 200 GS/s or 4 x 33 GHz, 100 GS/s
DPS75004SX	50 GHz ATI Performance Oscilloscope System: 2 x 50 GHz, 200 GS/s or 4 x 33 GHz, 100 GS/s
DPS73308SX	33 GHz Digital Phosphor Oscilloscope System: 4 x 33 GHz, 100 GS/s or 8 ⁶ x 23 GHz, 50 GS/s

Standard accessories

ATI channel accessories

Accessory	Tektronix part number
Deskew adapter (1.85M to 2.92F)	103-0488-00
ATI connector saver (1.85 mm)	103-0474-00
ATI protective cap	016-2101-00
Torque wrench	067-2787-00
Backing wrench	003-1942-00

Instrument accessories

Accessory	Tektronix part number
User manual -- depends on language option	071-3357-xx
Front protective cover	200-5337-00
PCIe Host Port protective plug	200-5344-00
2nd ethernet port plug	200-5389-00
50 Ω term on Fast Edge (2X)	015-1022-01
TCA292D (5X) (3X on ATI instruments)	090-0058-00
Windows compatible keyboard	119-7275-xx
Windows compatible mouse	119-7054-xx
Static protection wrist strap	006-3415-05
Deskew cable (M2.92 to M2.92)	174-6793-00

⁶ Maximum of 4 channels displayed on-screen. Additional channels data available through program interface.

Accessory	Tektronix part number
Accessories pouch	016-2045-00
Best Practices manual	071-2989-04
RoHS info	071-2185-04
Calibration certification	001-1179-00
Cal cert envelope	006-8018-01
Power cord	Depends on option

Warranty

One-year warranty covering all parts and labor.

Instrument options

Record length options

Option	Description
Opt. 10XL	125 MS/Ch
Opt. 20XL	250 MS/Ch
Opt. 50XL	500 MS/Ch on 4 channels, 1 GS/Ch on 2 channels

Advanced analysis options

Option	Description
Opt. DDR4	DDR Memory Bus Analysis (Requires Opt. DJA)
Opt. DDR-LP4	LPDDR4 Memory Bus Electrical Validation and Analysis Oscilloscope Software (Requires Opt. DJA)
Opt. DJA	Jitter and Eye Analysis Tools - Advanced (DPOJET)
Opt. DJAN	DPOJET Noise, Jitter and Eye Analysis Tools
Opt. DP12	DisplayPort 1.2 Source Test Automation Software (Requires Opt. DJA and 5XL)
Opt. D-PHY	MIPI D-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires Opt. DJA)
Opt. EDP	Embedded Display Port (EDP) v1.4 TX Compliance Test Package
Opt. ET3	Ethernet Compliance Testing
Opt. FC-16G	Fiber Channel - 16G Essentials (Requires Opt. DJA)
Opt. FRQCNT	Frequency Counter-Timer
Opt. HDM	HDMI 2.0 Advanced Analysis and Compliance Software for Tx tests
Opt. HDM-DS	HDMI 2.0 Direct Synthesis for RX testing
Opt. HSSLTA	High Speed Serial Link Training Analysis.
Opt. HT3	HDMI Compliance Testing
Opt. HT3DS	HDMI Direct Synthesis for HDMI 1.4 (Requires Opt. HT3)
Opt. LT	Waveform Limit Testing
Opt. MHD	MHL Advanced Analysis and Compliance Software (Requires Opt. DJA and 2XL)
Opt. M-PHY	MIPI M-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires Opt. DJA)
Opt. M-PHYTX	M-PHY Automated Transmitter Solution
Opt. NBASET	NBASE-T TekExpress Conformance and Debug Solution
Opt. PAM4	PAM4 Electrical Transmitter Analysis Software
Opt. PAM4-O	PAM4 Analysis for optical signals
Opt. PCE3	PCI Express Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJet Measurements Software (Requires Opt. DJA)

Option	Description
Opt. PCE4	PCI Express Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJET and SigTest Measurements Software, Gen 4 Debug with DPOJET Measurement Library (Requires Opt. DJA and Opt. SDLA64)
Opt. PWR	Power Measurement and Analysis
Opt. SAS3	SAS-3 Tx Compliance Test Application (Requires Opt. DJA and >2XL)
Opt. SAS3-TSG	SAS-3 Automated Tx Compliance Test Application (Requires Opt. DJA)
Opt. SAS3-TSGW	SAS-3 WDP Transmitter Measurements (Requires Opt. SAS3-TSG)
Opt. SATA-TSG	SATA PHY/TSG/OOB Transmitter Tests for TekExpress
Opt. SATA-T-UP	TEKEXP Upgrade to SATA PHY/TSG/OOB Transmitter Tests for TekExpress
Opt. SC	SignalCorrect Cable, Channel, and Probe Compensation Software
Opt. SDLA64	Serial Data Link Analysis
Opt. SFP-TX	SFP+ Compliance and Debug Solution (Requires Opt. DJA)
Opt. SFP-WDP	SFP+ Compliance and Debug Solution ? WDP Measurement (Requires Opt. DJA & SFP-TX)
Opt. SR-EMBD	Embedded Serial Triggering and Analysis (I2C, SPI)
Opt. SR-COMP	Computer Serial Triggering and Analysis (RS-232/422/485/UART)
Opt. SR-ENET	Ethernet Serial Analysis (10BASE-T and 100BASE-TX)
Opt. SR-PCIE	PCI EXPRESS Serial Analysis
Opt. SR-USB	USB Serial Triggering and Analysis
Opt. ST14G	8b/10b Serial Trigger and Analysis
Opt. USB2	USB 2.0 Automated Compliance Test Application
Opt. USBSSP-TX	USB 3.1 Automated TX Compliance Test Application
Opt. USBSSP-UP	USB-TX to USBSSP-TX Upgrade
Opt. USB-TX	TekExpress Automated USB 3.0 Solution
Opt. USB-TX-UP	TEKEXP USB-TX to USB-TX Upgrade
Opt. VET	Visual Trigger and Search
Opt. XGBT2	10GBASE-TekExpress Conformance and Debug Solution
Opt. 100G-TXE	IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance (Requires Opt. DJA or DSA and DJAN)
Opt. 10G-KR	10GBASE-KR/KR4 Compliance and Debug Solution (Requires Opt. DJA, SR-CUST)
Opt. 40G-CR4	40GBASE-CR4 Debug and Automated Compliance Solution

Spectral and modulation analysis

Option	Description
Opt. SVA	AM/FM/PM Audio Signal Analysis (Requires Opt. SVE)
Opt. SVE	SignalVu® Essentials - Vector Signal Analysis Software
Opt. SVM	General Purpose Modulation Analysis (Requires Opt. SVE)
Opt. SVO	Flexible OFDM Analysis (Requires Opt. SVE)
Opt. SVP	Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE)
Opt. SVT	Frequency and Phase Settling Time Measurements (Requires Opt. SVE)
Opt. SV23	WLAN802.11a/b/g/j/p measurement application (Requires Opt. SVE)
Opt. SV24	WLAN 802.11n measurement application (Requires Opt SV23)
Opt. SV25	WLAN 802.11ac measurement application (Requires Opt SV24)
Opt. SV26	APCO P25 compliance testing and analysis application (Requires Opt. SVE)
Opt. SV27	SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE)

Option	Description
Opt. SV28	SignalVu LTE Downlink RF measurements (Requires Opt. SVE)
Opt. SV30	WiGig IEEE802.11ad transmitter testing (Requires Opt. SVE)

Storage options

Option	Description
Opt. SSD	Additional removable drive with Microsoft Windows 10 OS, TekScope, and applications software installed

Floating license options

Floating licenses offer an alternative method to manage your Tektronix asset. Floating licenses allow license-key enabled options to be easily moved among all your MSO/ DPO70000, DPO7000, and MSO/DPO5000 Series oscilloscopes. Floating licenses are available for the license-key enabled options listed below.

Check www.tek.com/products/oscilloscopes/floating-licenses for additional information about floating license options.

Option	Description
DPOFL-DDRA	DDR Memory Bus Analysis (Requires Opt. DJA)
DPOFL-DDR-LP4	LPDDR4 Memory Bus Electrical Validation and Analysis Oscilloscope Software (Requires Opt. DJA)
DPOFL-DJA	Jitter and Eye Analysis Tools - Advanced (DPOJET)
DPOFL-DJAN	DPOJET Noise, Jitter and Eye Analysis Tools
DPOFL-DP12	DisplayPort 1.2 Source Test Automation Software (Requires Opt. DJA and 5XL)
DPOFL-D-PHY	MIPI D-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires Opt. DJA)
DPOFL-EDP	Embedded Display Port (EDP) v1.4 TX Compliance Test Package
DPOFL-ET3	Ethernet Compliance Testing
DPOFL-FC-16G	Fiber Channel - 16G Essentials (Requires Opt. DJA)
DPOFL-FRQCNT	Frequency Counter-Timer
DPOFL-HDM	HDMI 2.0 Advanced Analysis and Compliance Software for Tx tests
DPOFL-HDM-DS	HDMI 2.0 Direct Synthesis for RX testing
DPOFL-HSSLTA	High Speed Serial Link Training Analysis.
DPOFL-HT3	HDMI Compliance Testing
DPOFL-HT3DS	HDMI Direct Synthesis for HDMI 1.4 (Requires Opt. HT3)
DPOFL-LT	Waveform Limit Testing
DPOFL-MHD	MHL Advanced Analysis and Compliance Software (Requires Opt. DJA and 2XL)
DPOFL-M-PHY	MIPI M-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires Opt. DJA)
DPOFL-M-PHYTX	M-PHY Automated Transmitter Solution
DPOFL-NBASET	NBASE-T TekExpress Conformance and Debug Solution
DPOFL-PAM4	PAM4 Electrical Transmitter Analysis Software
DPOFL-PAM4-O	PAM4 Analysis for optical signals
DPOFL-PCE3	PCI Express Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJet Measurements Software (Requires Opt. DJA)
DPOFL-PCE4	PCI Express Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJET and SigTest Measurements Software, Gen 4 Debug with DPOJET Measurement Library (Requires Opt. DJA and Opt SDLA64)
DPOFL-PWR	Power Measurement and Analysis
DPOFL-SAS3	SAS-3 Tx Compliance Test Application (Requires Opt. DJA and >2XL)
DPOFL-SAS3-TSG	SAS-3 Automated Tx Compliance Test Application (Requires Opt. DJA)
DPOFL-SAS3-TSGW	SAS-3 WDP Transmitter Measurements (Requires Opt. SAS3-TSG)
DPOFL-SATA-TSG	SATA PHY/TSG/OOB Transmitter Tests for TekExpress
DPOFL-SATA-T-UP	TEKEXP Upgrade to SATA PHY/TSG/OOB Transmitter Tests for TekExpress

Option	Description
DPOFL-SC	SignalCorrect Cable, Channel, and Probe Compensation Software
DPOFL-SDLA64	Serial Data Link Analysis
DPOFL-SFP-TX	SFP+ Compliance and Debug Solution (Requires Opt. DJA)
DPOFL-SFP-WDP	SFP+ Compliance and Debug Solution WDP Measurement (Requires Opt. DJA & SFP-TX)
DPOFL-SR-EMBD	Embedded Serial Triggering and Analysis (I2C, SPI)
DPOFL-SR-COMP	Computer Serial Triggering and Analysis (RS-232/422/485/UART)
DPOFL-SR-ENET	Ethernet Serial Analysis (10BASE-T and 100BASE-TX)
DPOFL-SR-PCIE	PCI EXPRESS Serial Analysis
DPOFL-ST14G	8b/10b Serial Trigger and Analysis
DPOFL-SR-USB	USB Serial Triggering and Analysis
DPOFL-SVA	AM/FM/PM Audio Signal Analysis (Requires Opt. SVE)
DPOFL-SVE	SignalVu® Essentials – Vector Signal Analysis Software
DPOFL-SVM	General Purpose Modulation Analysis (Requires Opt. SVE)
DPOFL-SVO	Flexible OFDM Analysis (Requires Opt. SVE)
DPOFL-SVP	Advanced Signal Analysis (including pulse measurements) (Requires Opt. SVE)
DPOFL-SVT	Frequency and Phase Settling Time Measurements (Requires Opt. SVE)
DPOFL SV23	WLAN 802.11a/b/g/j/p measurement application (Requires Opt. SVE)
DPOFL SV24	WLAN 802.11n measurement application (Requires Opt. SV23)
DPOFL SV25	WLAN 802.11ac measurement application (Requires Opt. SV24)
DPOFL-SV26	APCO P25 compliance testing and analysis application
DPOFL-SV27	SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE)
DPOFL-SV28	SignalVu LTE Downlink RF measurements (Requires Opt. SVE)
DPOFL-SV30	WiGig IEEE802.11ad transmitter testing (Requires Opt. SVE)
DPOFL-USB2	USB 2.0 Automated Compliance Test Application
DPOFL-USBSSP-TX	USB 3.1 Automated TX Compliance Test Application
DPOFL-USBSSP-UP	USB-TX to USBSSP-TX Upgrade
DPOFL-USB-TX	TekExpress Automated USB 3.0 Solution
DPOFL-USB-TX-UP	TEKEXP USB-TX to USB-TX Upgrade
DPOFL-VET	Visual Trigger and Search
DPOFL-XGBT2	10GBASE-TekExpress Conformance and Debug Solution
DPOFL-XL010	Extended record length – 125 M Samples/Ch
DPOFL-XL020	Extended record length – 250 M Samples/Ch
DPOFL-XL050	Extended record length - 500M Samples each Ch, 1G Samples on 2 Ch (DX models only)
DPOFL-100G-TXE	IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance (Requires Opt. DJA or DSA and DJAN)
DPOFL-10G-KR	10GBASE-KR/KR4 Compliance and Debug Solution (Requires Opt. DJA, SR-CUST)
DPOFL-40G-CR4	40GBASE-CR4 Debug and Automated Compliance Solution

Upgrade options

The DPO70000SX Series instruments can be easily upgraded after initial time of purchase. To upgrade an existing DPO70000SX, order DPO-UP and an option listed below. For example, DPO-UP DJAN.

Memory upgrades for DPO70000SX Series

XL510	Standard Configuration to Option 10XL Configuration
XL520	Standard Configuration to Option 20XL Configuration
XL550	Standard Configuration to Option 50XL Configuration
XL1020	Option 10XL Configuration to Option 20XL Configuration
XL1050	Option 10XL Configuration to Option 50XL Configuration
XL2050	Option 20XL Configuration to Option 50XL Configuration

Advanced analysis upgrades for DPO70000SX Series

Option	Description
DDRA	DDR Memory Bus Analysis (Requires Opt. DJA)
DDR-LP4	LPDDR4 Memory Bus Electrical Validation and Analysis Oscilloscope Software (Requires Opt. DJA)
DJA	Jitter and Eye Analysis Tools - Advanced (DPOJET)
DJAN	DPOJET Noise, Jitter and Eye Analysis Tools
DP12	DisplayPort 1.2 Source Test Automation Software (Requires Opt. DJA and 5XL)
D-PHY	MIPI D-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires Opt. DJA)
EDP	Embedded Display Port (EDP) v1.4 TX Compliance Test Package
ET3	Ethernet Compliance Testing
FC-16G	Fiber Channel - 16G Essentials (Requires Opt. DJA)
FRQCNT	Frequency Counter-Timer
HDM	HDMI 2.0 Advanced Analysis and Compliance Software for Tx tests
HDM-DS	HDMI 2.0 Direct Synthesis for RX testing
HSSLTA	High Speed Serial Link Training Analysis.
HT3	HDMI Compliance Testing
HT3DS	HDMI Direct Synthesis for HDMI 1.4 (Requires Opt. HT3)
LT	Waveform Limit Testing
MHD	MHL Advanced Analysis and Compliance Software (Requires Opt. DJA and 2XL)
M-PHY	MIPI M-PHY Transmitter Debug, Characterization and Compliance Test Solution (Requires Opt. DJA)
M-PHYTX	M-PHY Automated Transmitter Solution
NBASET	NBASE-T TekExpress Conformance and Debug Solution
PAM4	PAM4 Electrical Transmitter Analysis Software
PAM4-O	PAM4 Analysis for optical signals
PCE3	PCI Express Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJet Measurements Software (Requires Opt. Opt DJA)
PCE4	PCI Express Gen1/2/3 TekExpress Compliance/Debug Automation with DPOJET and SigTest Measurements Software, Gen 4 Debug with DPOJET Measurement Library (Requires Opt. DJA and Opt SDLA64)
Opt. PWR	Power Measurement and Analysis
SAS3	SAS-3 Tx Compliance Test Application (Requires Opt. DJA and >2XL)
SAS3-TSG	SAS-3 Automated Tx Compliance Test Application (Requires Opt. DJA)
SAS3-TSGW	SAS-3 WDP Transmitter Measurements (Requires Opt. SAS3-TSG)
SATA-TSG	SATA PHY/TSG/OOB Transmitter Tests for TekExpress
SATA-T-UP	TEKEXP Upgrade to SATA PHY/TSG/OOB Transmitter Tests for TekExpress
SC	SignalCorrect Cable, Channel, and Probe Compensation Software
SDLA64	New version of SDLA (64-bit)
SFP-TX	SFP+ Compliance and Debug Solution (Requires Opt. DJA)
SFP-WDP	SFP+ Compliance and Debug Solution ? WDP Measurement (Requires Opt. DJA & SFP-TX)

Option	Description
SR-EMBD	Embedded Serial Triggering and Analysis (I2C, SPI)
SR-COMP	Computer Serial Triggering and Analysis (RS-232/422/485/UART)
SR-ENET	Ethernet Serial Analysis (10BASE-T and 100BASE-TX)
SR-PCIE	PCI EXPRESS Serial Analysis
SR-USB	USB Serial Triggering and Analysis
ST14G	8b10b Serial Trigger and Analysis
USB2	USB 2.0 Automated Compliance Test Application
USBSSP-TX	USB 3.1 Automated TX Compliance Test Application
USBSSP-UP	USB-TX to USBSSP-TX Upgrade
USB-TX	TekExpress Automated USB 3.0 Solution
USB-TX-UP	TEKEXP USB-TX to USB-TX Upgrade
VET	Visual Trigger and Search
XGBT2	10GBASE-TekExpress Conformance and Debug Solution
100G-TXE	IEEE-802.3bm: CAUI4 and IEEE-802.3bj: KR4/CR4 100Gbps Transmitter Compliance (Requires Opt. DJA or DSA and DJAN)
10G-KR	10GBASE-KR/KR4 Compliance and Debug Solution (Requires Opt. DJA, SR-CUST)
40G-CR4	40GBASE-CR4 Debug and Automated Compliance Solution

Spectral and modulation analysis upgrades for DPO7000SX Series

Option	Description
SVEU	SignalVu® Essentials - Vector Signal Analysis Software
SVA	AM/FM/PM Audio Signal Analysis (Requires Opt. SVE, SVEH, or SVEU)
SVE	SignalVu Essentials Vector Signal Analysis Software
SVM	General Purpose Modulation Analysis (Requires Opt. SVE, SVEH, or SVEU)
SVO	Flexible OFDM Analysis (Requires Opt. SVE, SVEH, or SVEU)
SVP	Advanced Pulsed Signal Analysis including Measurements (Requires Opt. SVE, SVEH, or SVEU)
SVT	Frequency and Phase Settling Time Measurements (Requires Opt. SVE, SVEH, or SVEU)
SV23	WLAN802.11a/b/g/j/p measurement application (Requires Opt. SVE, SVEH, or SVEU)
SV24	WLAN 802.11n measurement application (Requires Opt SV23)
SV25	WLAN 802.11ac measurement application (Requires Opt SV24)
SV26	APCO P25 compliance testing and analysis application (Requires Opt. SVE)
SV27	SignalVu Bluetooth Basic LE TX SIG measurements (Requires Opt. SVE, SVEH, or SVEU)
SV28	SignalVu LTE Downlink RF measurements (Requires Opt SVE)
SV30	WiGig IEEE802.11ad transmitter testing (Requires Opt. SVE, SVEH, or SVEU)

Other upgrades

SSD-SX (all 70kSX models except 70GHz)	Spare Solid State Drive - Windows 7 , preconfigured with OS, TekScope, and scope applications
DPOSX-SSD70G (only for 70 GHz models)	Spare Solid State Drive - Windows 7 , for 70GHz scopes preconfigured with OS, TekScope and scope applications
DPO7SXSSD-W10 DPO7SXSSD-W10 opt NOL (all 70kSX models except 70 GHz, order both line items)	Spare Solid State Drive - Windows 10 , for scopes already licensed and running Win10. Preconfigured with OS, TekScope and scope applications.
DPO7SXSSD-W10 DPO7SXSSD-W10 opt UP (all 70kSX models except 70 GHz, order both line items)	Upgrade Solid State Drive - Windows 10 , for scopes currently licensed and running Win7. Upgrades to Win10. Preconfigured with OS, TekScope and scope applications.
DPO7SXSSD70GW10 DPO7SXSSD70GW10 opt NOL (only for 70 GHz models, order both line items)	Spare Solid State Drive - Windows 10 , for 70 GHz scopes already licensed and running Win10. Preconfigured with OS, TekScope and scope applications.

Investment protection options

As signals get faster and new standards are developed, your investment in an DPO70000SX Series instrument can evolve with your needs. You can upgrade the bandwidth of the unit you own today. You can take advantage of DPO70000SX Series performance improvements by upgrading your existing unit to a new series. Contact your local Tektronix representative to discuss the full range of options available to ensure your DPO70000SX Series oscilloscope has the tools you need for your next project.

Power plug options

Opt. A0	North America power plug (115 V, 60 Hz)
Opt. A1	Universal Euro power plug (220 V, 50 Hz)
Opt. A2	United Kingdom power plug (240 V, 50 Hz)
Opt. A3	Australia power plug (240 V, 50 Hz)
Opt. A5	Switzerland power plug (220 V, 50 Hz)
Opt. A6	Japan power plug (100 V, 50/60 Hz)
Opt. A10	China power plug (50 Hz)
Opt. A11	India power plug (50 Hz)
Opt. A12	Brazil power plug (60 Hz)
Opt. A99	No power cord

Service options

Opt. C3	Calibration Service 3 Years
Opt. C5	Calibration Service 5 Years
Opt. D1	Calibration Data Report
Opt. D3	Calibration Data Report 3 Years (with Opt. C3)
Opt. D5	Calibration Data Report 5 Years (with Opt. C5)
Opt. G3	Complete Care 3 Years (includes loaner, scheduled calibration, and more)
Opt. G5	Complete Care 5 Years (includes loaner, scheduled calibration, and more)
Opt. IF	Upgrade Installation Service
Opt. R3	Repair Service 3 Years (including warranty)
Opt. R5	Repair Service 5 Years (including warranty)

Recommended accessories

Probes

DPO7OE1	33 GHz optical probe
DPO7OE2	59 GHz optical probe
P7633	33 GHz Low Noise TriMode® Probe
P7625	25 GHz Low Noise TriMode® Probe
P7520A	25 GHz TriMode® probe
P7720	20 GHz TriMode probe with TekFlex™ connector technology
P7313SMA	13 GHz TriMode® differential SMA probe
P6251	DC to 1 GHz, 42 V, differential probe (requires TCA-BNC adapter)
TCPA300/TCPA400 Series	Current measurement systems
P5200/P5205/P5210	High-voltage differential probes
P77DESKEW	P7700 Probe Deskew Fixture for SMA, solder-down, and browser connections
067-2431-xx	Probe Deskew Fixture for SMA or solder-down connections (up to 30 GHz)
067-0484-xx	Analog Probe Calibration and Deskew Fixture (4 GHz)
067-1586-xx	Analog Probe Deskew Fixture (>4 GHz)
067-1686-xx	Power Deskew Fixture

Adapters

TCA-1MEG	TekConnect® high-impedance buffer amplifier. Includes P6139A passive probe
TCA292D	TekConnect® to 2.92 mm adapter (33 GHz bandwidth)
TCA-BNC	TekConnect® to BNC adapter
TCA-N	TekConnect® to N adapter
TCA-VPI50	50 Ω TekVPI to TekConnect adapter
TCA75	23 GHz precision TekConnect® 75 Ω to 50 Ω adapter with 75 Ω BNC input connector

Signal Path Solutions

DPO7RFK1	3 dB, 6 dB, 10 dB, and 20 dB attenuator kit with 1.85 mm connectors, characterized to 70 GHz. Includes serial numbers and S-parameters for each attenuator.
DPO7RFK2	Includes the contents of the DPO7RFK1 plus a DC Block and 4 adapters for connecting to 1.85 and 2.92 mm fixtures.
DPO7RFK3	RF channel timing de-skew kit, 65 GHz, 1.85 mm. Kit includes a high performance power divider and 1.85 mm male-male adapter.
DPO7RFC1	Matched cable pair, 67 GHz, 1.85 mm, male-male, 24 inch, characterized to 70 GHz with provided S-parameters.
DPO7RFC2	Phase-stable coaxial cable, 67 GHz, 1.85 mm, male-male, 24 inch. Kit includes S-parameter data to 70 GHz.
DPO7RFC3	Phase-stable coaxial cable, 67 GHz, 1.85 mm, male-male, 36 inch. Kit includes S-parameter data to 70 GHz.

Other

016-2095-xx	Rackmount Kit
016-2102-xx	SSD mounting kit (front of instrument rackmount tray)
077-0076-xx	Service Manual, pdf on hard drive
016-2104-00	Transit Case (carbon fiber)
K4000	Oscilloscope Cart
DPO7AFP	Auxiliary Front Panel
DPO7USYNC 1M	1 meter UltraSync cable
DPO7USYNC 2M	2 meter UltraSync cable



The DPO7000SX Series offers the highest performance in Tektronix' Real Time performance oscilloscope portfolio.



Tektronix is registered to ISO 9001 and ISO 14001 by SRI Quality System Registrar.



Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.



Product Area Assessed: The planning, design/development and manufacture of electronic Test and Measurement instruments.

ASEAN / Australasia (65) 6356 3900
Belgium 00800 2255 4835*
Central East Europe and the Baltics +41 52 675 3777
Finland +41 52 675 3777
Hong Kong 400 820 5835
Japan 81 (3) 6714 3086
Middle East, Asia, and North Africa +41 52 675 3777
People's Republic of China 400 820 5835
Republic of Korea +822 6917 5084, 822 6917 5080
Spain 00800 2255 4835*
Taiwan 886 (2) 2656 6688

Austria 00800 2255 4835*
Brazil +55 (11) 3759 7627
Central Europe & Greece +41 52 675 3777
France 00800 2255 4835*
India 000 800 650 1835
Luxembourg +41 52 675 3777
The Netherlands 00800 2255 4835*
Poland +41 52 675 3777
Russia & CIS +7 (495) 6647564
Sweden 00800 2255 4835*
United Kingdom & Ireland 00800 2255 4835*

Balkans, Israel, South Africa and other ISE Countries +41 52 675 3777
Canada 1 800 833 9200
Denmark +45 80 88 1401
Germany 00800 2255 4835*
Italy 00800 2255 4835*
Mexico, Central/South America & Caribbean 52 (55) 56 04 50 90
Norway 800 16098
Portugal 80 08 12370
South Africa +41 52 675 3777
Switzerland 00800 2255 4835*
USA 1 800 833 9200

* European toll-free number. If not accessible, call: +41 52 675 3777

For Further Information. Tektronix maintains a comprehensive, constantly expanding collection of application notes, technical briefs and other resources to help engineers working on the cutting edge of technology. Please visit www.tek.com.

Copyright © Tektronix, Inc. All rights reserved. Tektronix products are covered by U.S. and foreign patents, issued and pending. Information in this publication supersedes that in all previously published material. Specification and price change privileges reserved. TEKTRONIX and TEK are registered trademarks of Tektronix, Inc. All other trade names referenced are the service marks, trademarks, or registered trademarks of their respective companies.



12 Mar 2018 55W-30662-19

